

EE5780 Advanced VLSI CAD

Lecture 7 Modified Nodal Analysis and SPICE Simulation Zhuo Feng

Introduction to SPICE

- **Simulation Program with Integrated Circuit Emphasis**
 - ▶ Developed in 1970's at Berkeley
 - ▶ Many commercial versions are available
 - ▶ HSPICE is a robust industry standard
 - ▼ Has many enhancements that we will use
- **Written in FORTRAN for punch-card machines**
 - ▶ Circuits elements are called *cards*
 - ▶ Complete description is called a SPICE *deck*

Writing Spice Decks

- **Writing a SPICE deck is like writing a good program**
 - ▶ Plan: sketch schematic on paper or in editor
 - ▼ Modify existing decks whenever possible
 - ▶ Code: strive for clarity
 - ▼ Start with name, email, date, purpose
 - ▼ Generously comment
 - ▶ Test:
 - ▼ Predict what results should be
 - ▼ Compare with actual
 - ▼ *Garbage In, Garbage Out!*

Example: RC Circuit

```
* rc.sp
* David_Harris@hmc.edu 2/2/03
* Find the response of RC circuit to rising input
```

```
*-----
```

```
* Parameters and models
```

```
*-----
```

```
.option post
```

```
*-----
```

```
* Simulation netlist
```

```
*-----
```

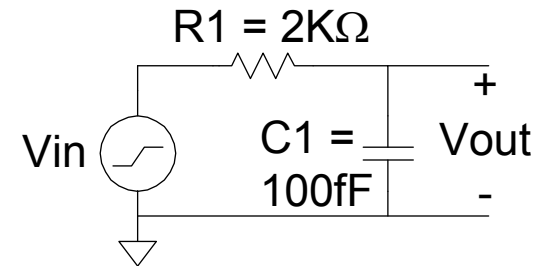
```
Vin      in      gnd      pwl      0ps 0 100ps 0 150ps 1.8 800ps 1.8
R1        in      out      2k
C1        out      gnd      100f
```

```
*-----
```

```
* Stimulus
```

```
*-----
```

```
.tran 20ps 800ps
.plot v(in) v(out)
.end
```



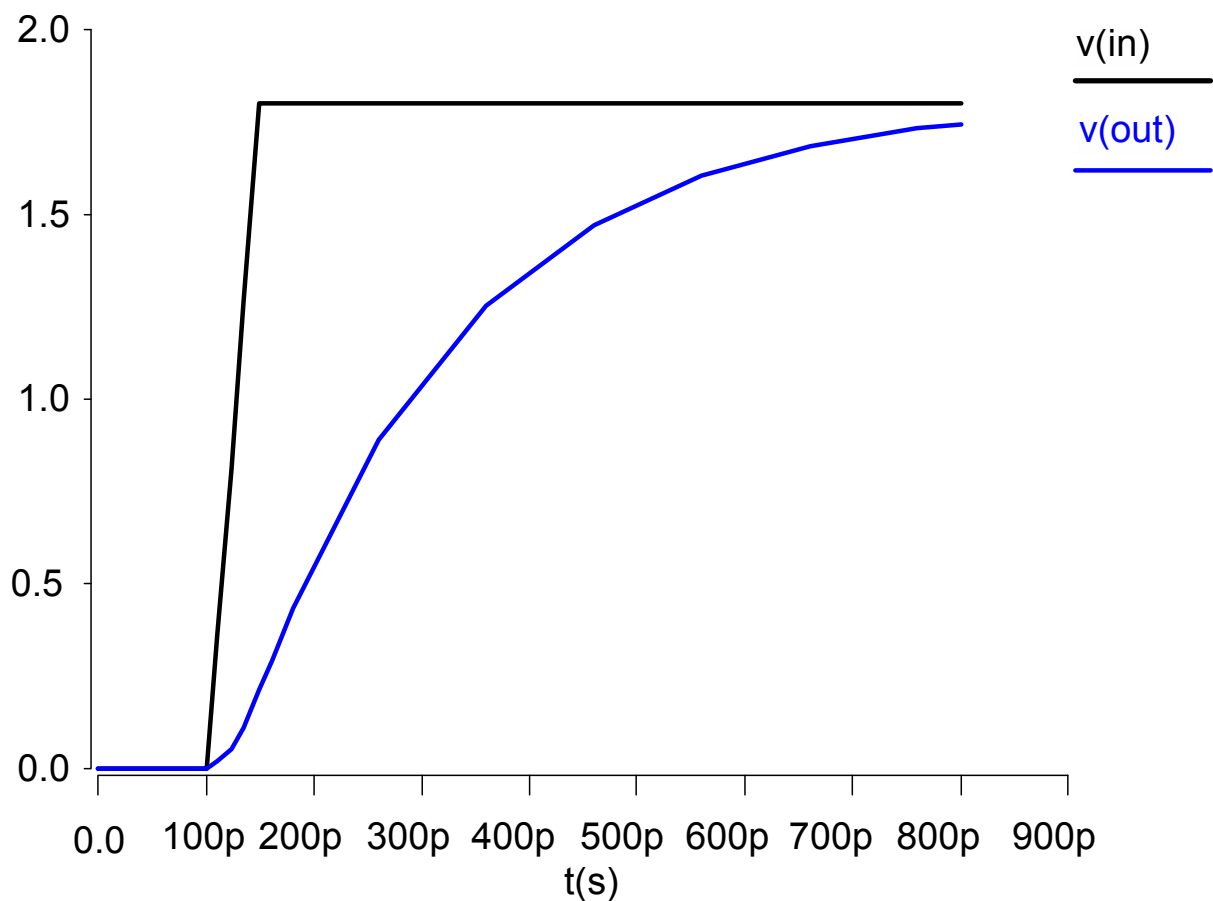
Result (Textual)

legend:

a: v(in)
b: v(out)

time (ab)	v(in) 0.	500.0000m	1.0000	1.5000	2.0000
0.	0.	+	+	+	+
20.0000p	0.	2	+	+	+
40.0000p	0.	2	+	+	+
60.0000p	0.	2	+	+	+
80.0000p	0.	2	+	+	+
100.0000p	0.	2	+	+	+
120.0000p	720.0000m	+b	+	+	+
140.0000p	1.440	+	+	+	+
160.0000p	1.800	+	+	+	+
180.0000p	1.800	+	+	+	+
200.0000p	1.800	+	+	+	+
220.0000p	1.800	+	+	+	+
240.0000p	1.800	+	+	+	+
260.0000p	1.800	+	+	+	+
280.0000p	1.800	+	+	+	+
300.0000p	1.800	+	+	+	+
320.0000p	1.800	+	+	+	+
340.0000p	1.800	+	+	+	+
360.0000p	1.800	+	+	+	+
380.0000p	1.800	+	+	+	+
400.0000p	1.800	+	+	+	+
420.0000p	1.800	+	+	+	+
440.0000p	1.800	+	+	+	+
460.0000p	1.800	+	+	+	+
480.0000p	1.800	+	+	+	+
500.0000p	1.800	+	+	+	+
520.0000p	1.800	+	+	+	+
540.0000p	1.800	+	+	+	+
560.0000p	1.800	+	+	+	+
580.0000p	1.800	+	+	+	+
600.0000p	1.800	+	+	+	+
620.0000p	1.800	+	+	+	+
640.0000p	1.800	+	+	+	+
660.0000p	1.800	+	+	+	+
680.0000p	1.800	+	+	+	+
700.0000p	1.800	+	+	+	+
720.0000p	1.800	+	+	+	+
740.0000p	1.800	+	+	+	+
760.0000p	1.800	+	+	+	+
780.0000p	1.800	+	+	+	+
800.0000p	1.800	+	+	+	+

Result (Graphical)



Sources

■ *DC Source*

Vdd vdd gnd 2.5

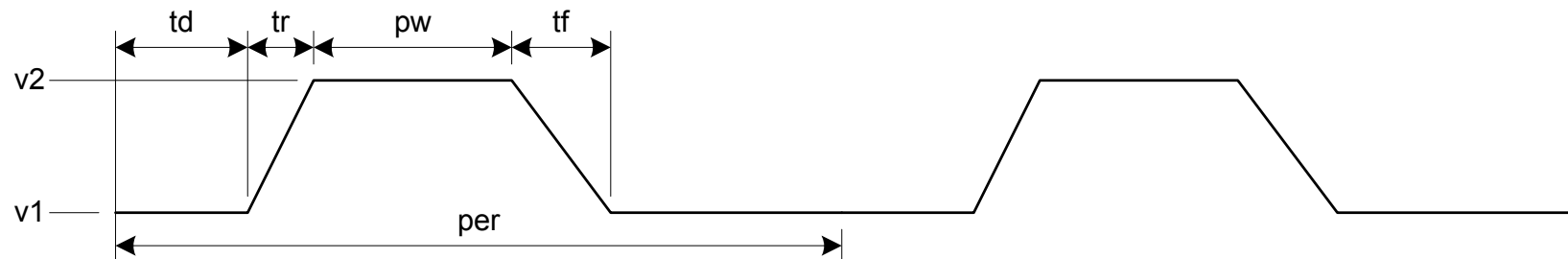
■ *Piecewise Linear Source*

Vin in gnd pwl 0ps 0 100ps 0 150ps 1.8 800ps 1.8

■ *Pulsed Source*

Vck clk gnd PULSE 0 1.8 0ps 100ps 100ps 300ps 800ps

PULSE v1 v2 td tr tf pw per



SPICE Elements

Letter	Element
R	Resistor
C	Capacitor
L	Inductor
K	Mutual Inductor
V	Independent voltage source
I	Independent current source
M	MOSFET
D	Diode
Q	Bipolar transistor
W	Lossy transmission line
X	Subcircuit
E	Voltage-controlled voltage source
G	Voltage-controlled current source
H	Current-controlled voltage source
F	Current-controlled current source

Units

Letter	Unit	Magnitude
a	atto	10^{-18}
f	femto	10^{-15}
p	pico	10^{-12}
n	nano	10^{-9}
u	micro	10^{-6}
m	mili	10^{-3}
k	kilo	10^3
x	mega	10^6
g	giga	10^9

Ex: 100 femptofarad capacitor = 100fF, 100f, 100e-15

DC Analysis

```
* mosiv.sp
```

```
*-----
```

```
* Parameters and models
```

```
*-----
```

```
.include '../models/tsmc180/models.sp'
```

```
.temp 70
```

```
.option post
```

```
*-----
```

```
* Simulation netlist
```

```
*-----
```

```
*nmos
```

```
Vgs      g      gnd      0
```

```
Vds      d      gnd      0
```

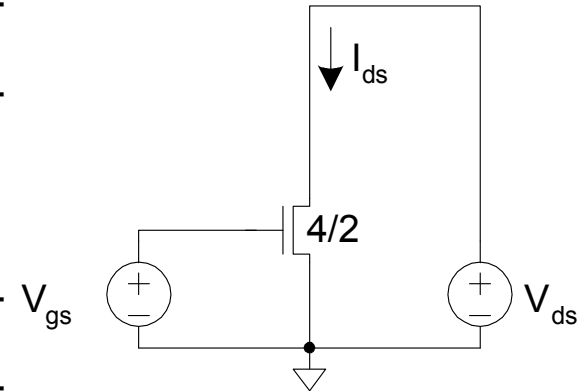
```
M1      d      g      gnd      gnd      NMOS      W=0.36u  L=0.18u
```

```
*-----
```

```
* Stimulus
```

```
*-----
```

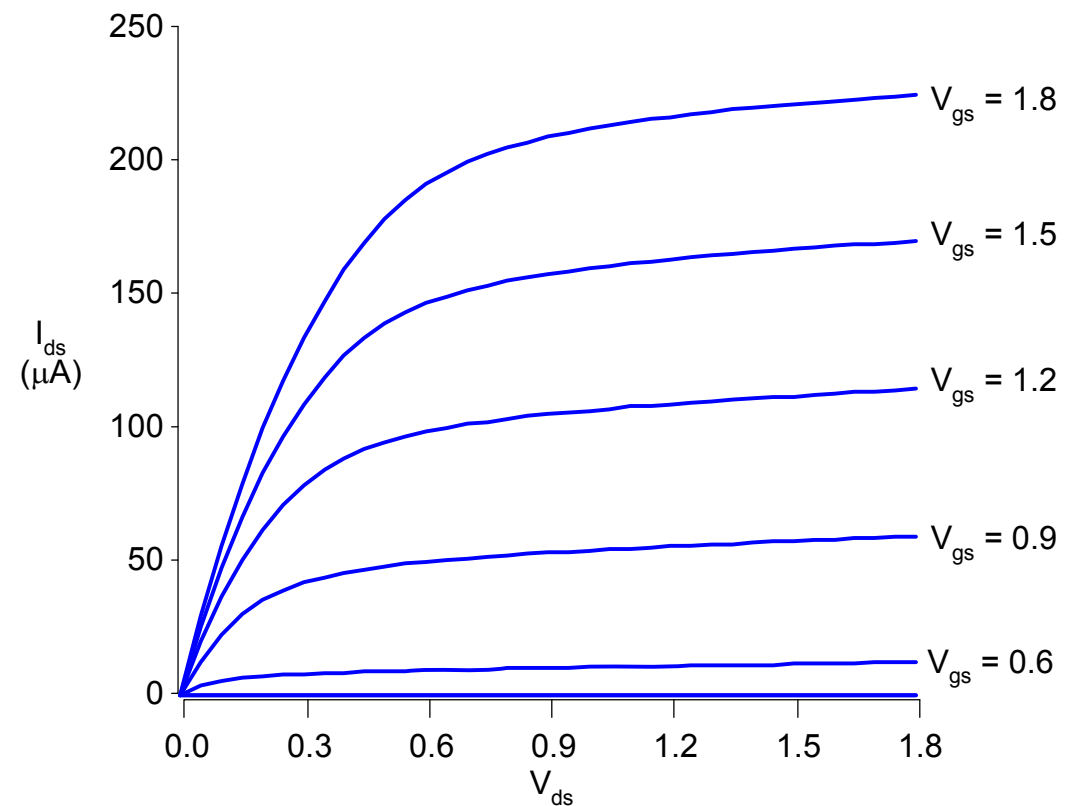
→ .dc Vds 0 1.8 0.05 SWEEP Vgs 0 1.8 0.3
.end



I-V Characteristics

■ NMOS I-V

- ▶ V_{gs} dependence
- ▶ Saturation



MOSFET Elements

M element for MOSFET

Mname drain gate source body type

+ W=<width> L=<length>

+ AS=<area source> AD = <area drain>

+ PS=<perimeter source> PD=<perimeter drain>

Transient Analysis

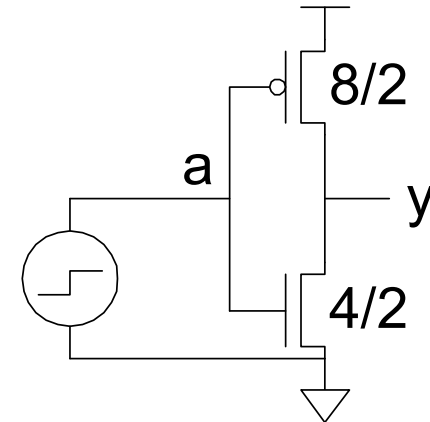
```
* inv.sp

* Parameters and models
*-----

.param SUPPLY=1.8
.option scale=90n
.include '../models/tsmc180/models.sp'
.temp 70
.option post

* Simulation netlist
*-----
Vdd      vdd      gnd      'SUPPLY'
Vin       a       gnd      PULSE    0 'SUPPLY' 50ps 0ps 0ps 100ps 200ps
M1        y       a       gnd      gnd      NMOS    W=4      L=2
+ AS=20 PS=18 AD=20 PD=18
M2        y       a       vdd      vdd      PMOS    W=8      L=2
+ AS=40 PS=26 AD=40 PD=26

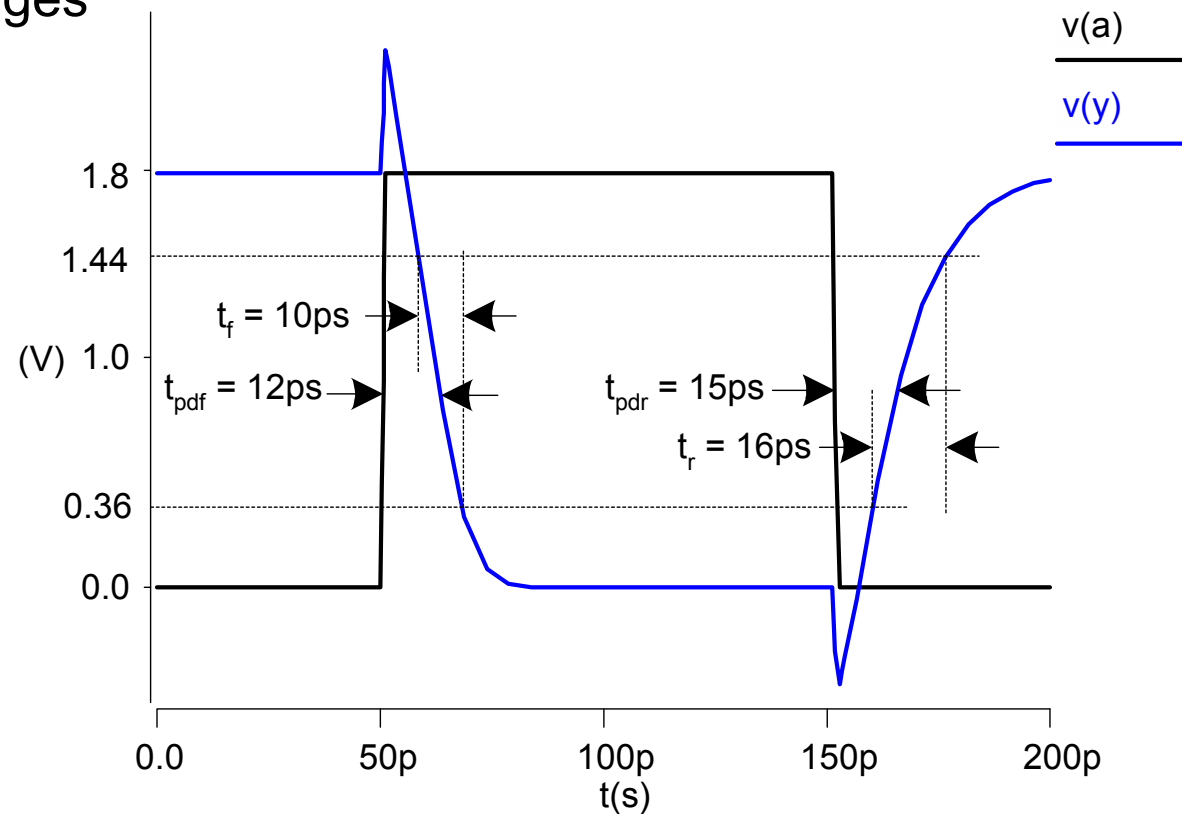
* Stimulus
*-----
→.tran 1ps 200ps
.end
```



Transient Results

■ Unloaded inverter

- Overshoot
- Very fast edges



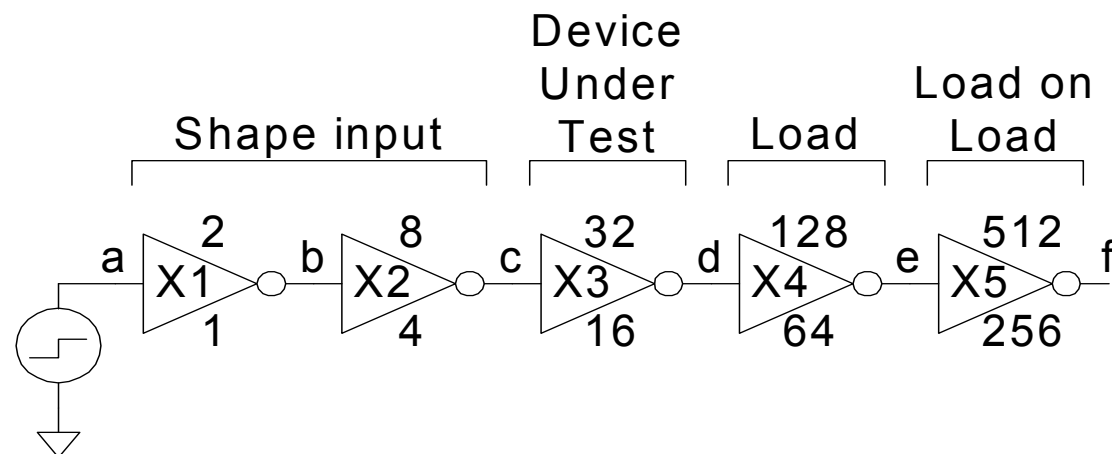
Subcircuits

■ Declare common elements as subcircuits

```
.subckt inv a y N=4 P=8
M1 y a gnd gnd NMOS W='N' L=2
+ AS='N*5' PS='2*N+10' AD='N*5' PD='2*N+10'
M2 y a vdd vdd PMOS W='P' L=2
+ AS='P*5' PS='2*P+10' AD='P*5' PD='2*P+10'
.ends
```

■ Ex: Fanout-of-4 Inverter Delay

- Reuse inv
- Shaping
- Loading



FO4 Inverter Delay

```
* fo4.sp

* Parameters and models
*-----

.param SUPPLY=1.8
.param H=4
.option scale=90n
.include '../models/tsmc180/models.sp'
.temp 70
.option post

* Subcircuits
*-----

.global vdd gnd
.include '../lib/inv.sp'

* Simulation netlist
*-----

Vdd      vdd      gnd      'SUPPLY'
Vin      a        gnd      PULSE    0 'SUPPLY' 0ps 100ps 100ps 500ps 1000ps
X1       a        b        inv                * shape input waveform
X2       b        c        inv      M='H'      * reshape input waveform
```


FO4 Inverter Delay Cont.

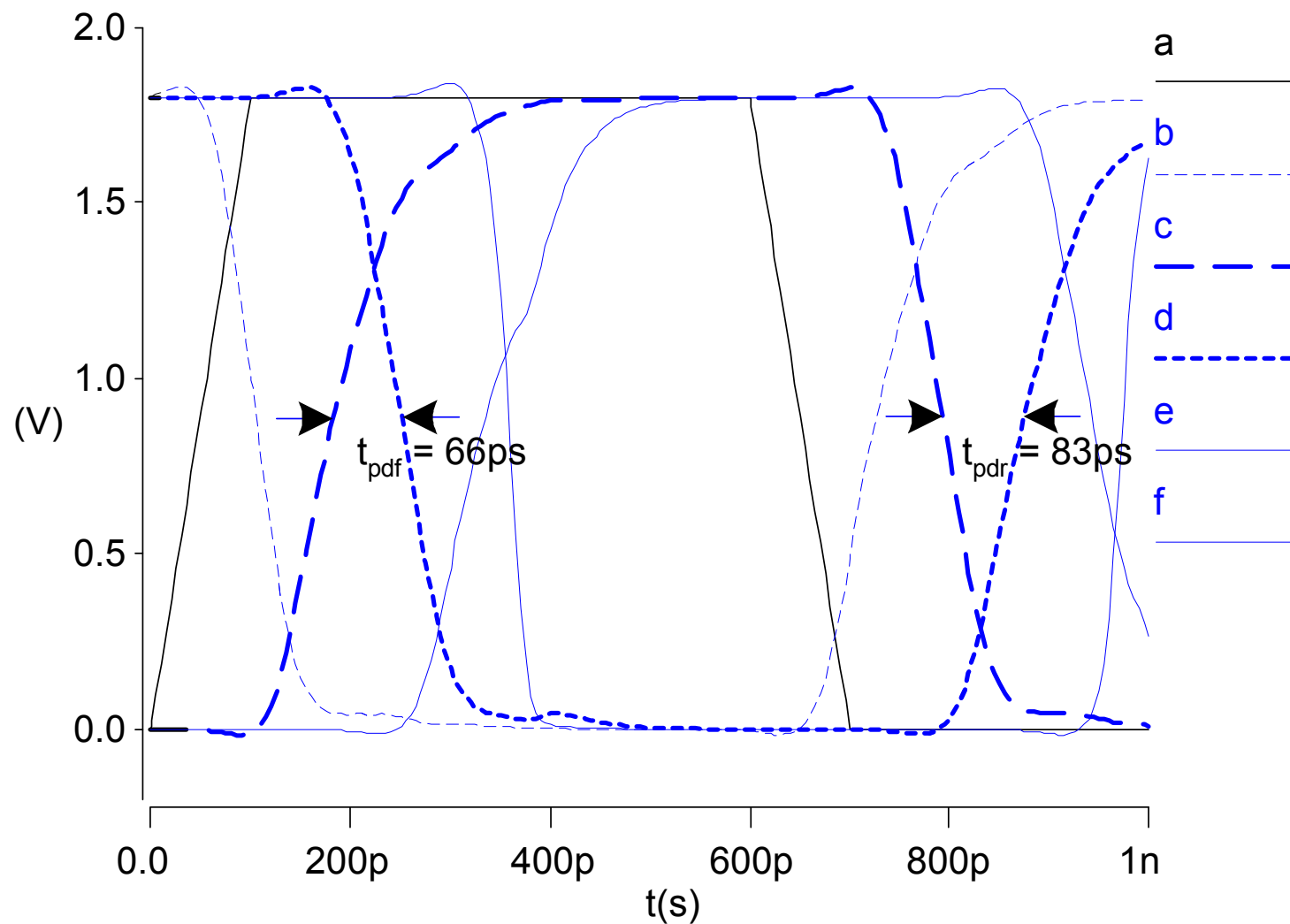
```

X3      c      d      inv      M='H**2' * device under test
X4      d      e      inv      M='H**3' * load
x5      e      f      inv      M='H**4' * load on load

* Stimulus
* -----
.tran 1ps 1000ps
.measure tpdr                                * rising prop delay
+      TRIG v(c)  VAL='SUPPLY/2' FALL=1
+      TARG v(d)  VAL='SUPPLY/2' RISE=1
.measure tpdf                                * falling prop delay
+      TRIG v(c)  VAL='SUPPLY/2' RISE=1
+      TARG v(d)  VAL='SUPPLY/2' FALL=1
.measure tpd param='(tpdr+tpdf)/2'          * average prop delay
.measure trise                                * rise time
+      TRIG v(d)          VAL='0.2*SUPPLY' RISE=1
+      TARG v(d)          VAL='0.8*SUPPLY' RISE=1
.measure tfall                                * fall time
+      TRIG v(d)          VAL='0.8*SUPPLY' FALL=1
+      TARG v(d)          VAL='0.2*SUPPLY' FALL=1
.end

```

FO4 Results



Power Measurement

■ HSPICE can measure power

- ▶ Instantaneous $P(t)$
- ▶ Or average P over some interval

```
.print P(vdd)
```

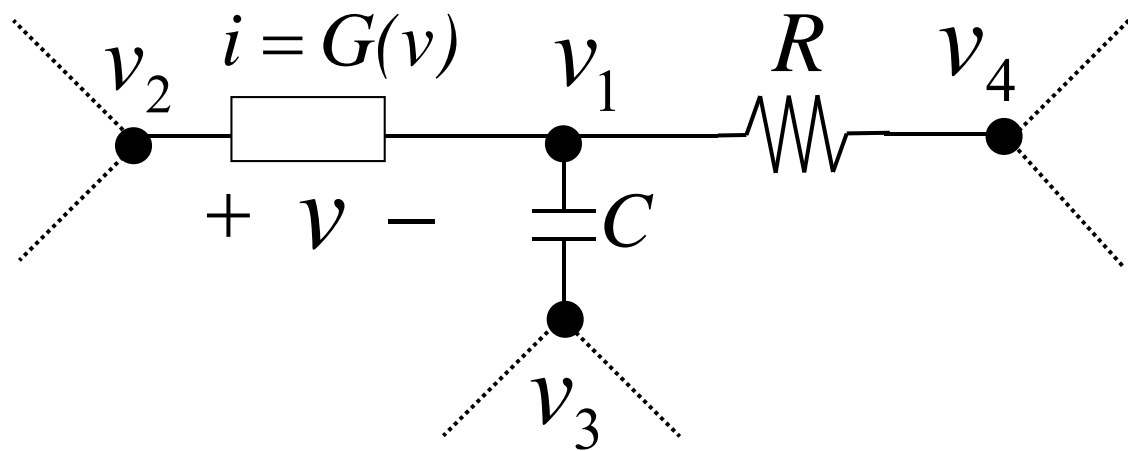
```
.measure pwr AVG P(vdd) FROM=0ns TO=10ns
```

■ Power in single gate

- ▶ Connect to separate V_{DD} supply
- ▶ Be careful about input power

■ How is SPICE simulator created?

- ▶ N equations in terms of N unknown Node voltages
- ▶ More generally using modified nodal analysis



Time Domain Equations at node 1:

$$C \frac{d(v_1 - v_3)}{dt} + \frac{(v_1 - v_4)}{R} - G(v_2 - v_1) = 0$$

► If we do this for all N nodes:

$$F(\vec{\dot{x}}(t), \vec{x}(t), \vec{u}(t)) = 0 \quad \vec{x}(0) = \vec{X}$$

$\vec{x}(t)$ = **N dimensional vector of unknown node voltages**

$\vec{u}(t)$ = **vector of independent sources**

F = **nonlinear operator**

- Closed form solution is not possible for arbitrary order of differential equations

- We must approximate the solution of:

$$F(\dot{\vec{x}}(t), \vec{x}(t), \vec{u}(t)) = 0 \quad \vec{x}(0) = \vec{X}$$

- This is facilitated in SPICE via numerical solutions

■ Basic circuit analyses

- ▶ (Nonlinear) DC analysis
 - ▼ Finds the DC operating point of the circuit
 - ▼ Solves a set of nonlinear algebraic eqns

- ▶ AC analysis
 - ▼ Performs frequency-domain small-signal analysis
 - ▼ Require a preceding DC analysis
 - ▼ Solves a set of complex linear eqns

- ▶ (Nonlinear) transient analysis
 - ▼ Computes the time-domain circuit transient response
 - ▼ Solves a set of nonlinear different eqns
 - ▼ Converts to a set nonlinear algebraic of eqns using numerical integration

- **SPICE offers practical techniques to solve circuit problems in time & freq. domains**
 - ▶ Interface to device models
 - ▼ Transistors, diodes, nonlinear caps etc
 - ▶ Sparse linear solver
 - ▶ Nonlinear solver – Newton-Raphson method
 - ▶ Numerical integration
 - ▶ Convergence & time-step control

■ Circuit equations are usually formulated using

▶ Nodal analysis

- ▼ N equations in N nodal voltages

▶ Modified analysis

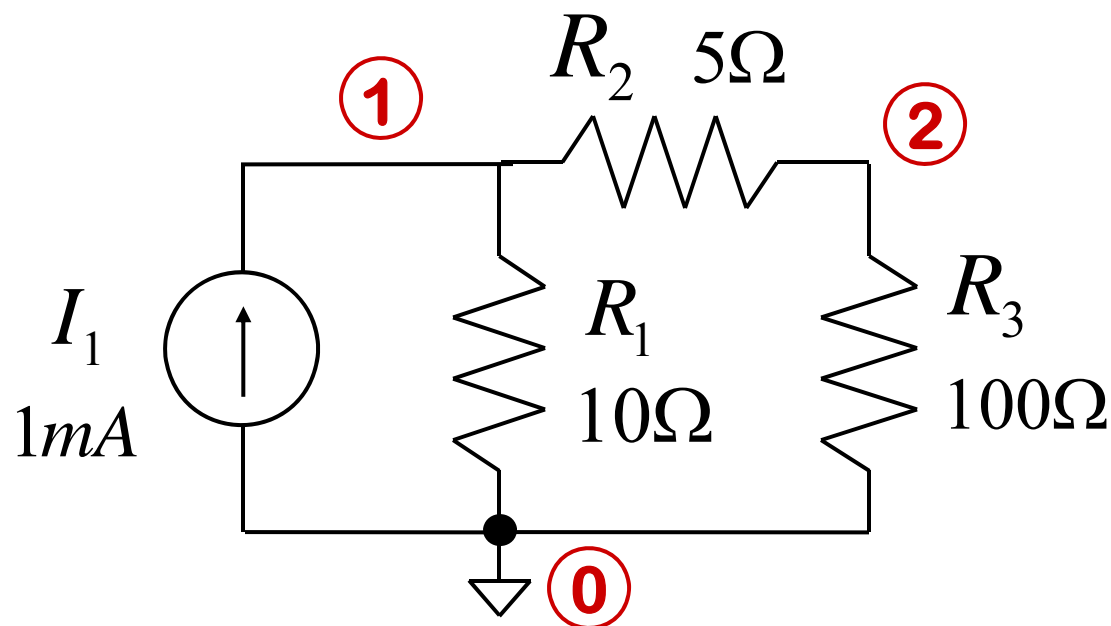
- ▼ Circuit unknowns are nodal voltages & some branch currents
- ▼ Branch current variables are added to handle
 - Voltages sources
 - Inductors
 - Current controlled voltage source etc

■ Formulations can be done in both time and frequency

How do we set up a matrix problem given a list of linear(ized) circuit elements?

Similar to reading a netlist for a linear circuit:

* Element Name	From	To	Value
I_1	0	1	1mA
R_1	1	0	10 Ω
R_2	1	2	5 Ω
R_3	2	0	100 Ω



The nodal analysis matrix equations are easily constructed via KCL at each node:

$$Y\vec{v} = \vec{J}$$

- **Naïve approach**

- ▶ a) Write down the KCL eqn for each node
- ▶ b) Combine all of them to get N eqns in N node voltages

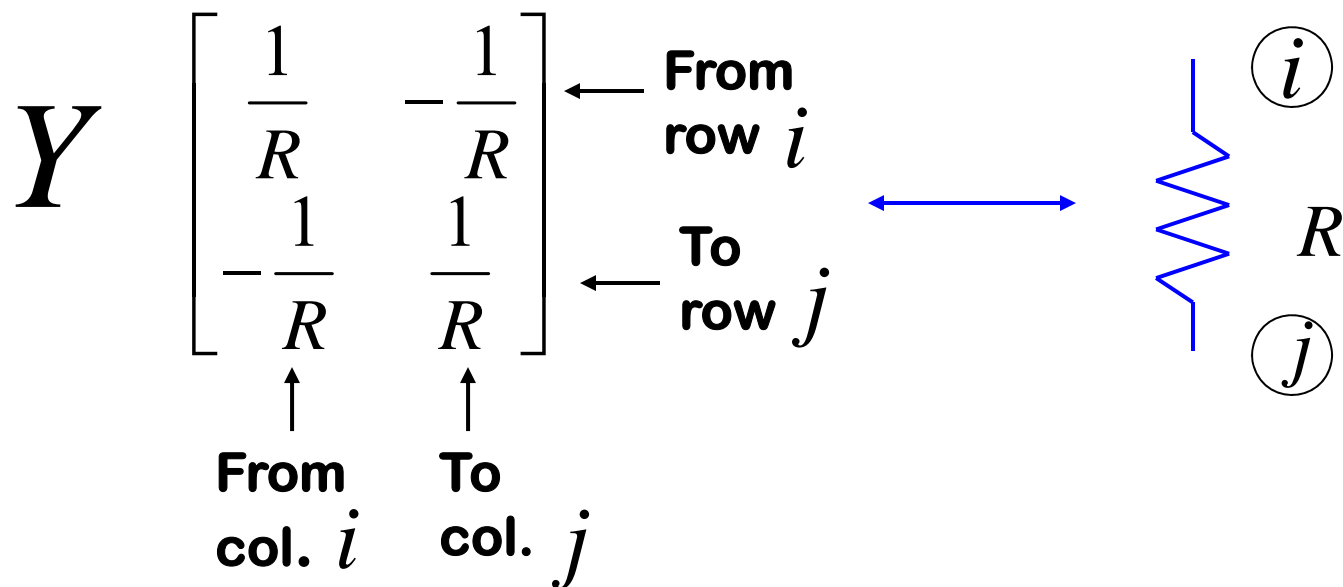
- **Intuitive for hand analysis**

- **Computer programs use a more convenient “element” centric approach**

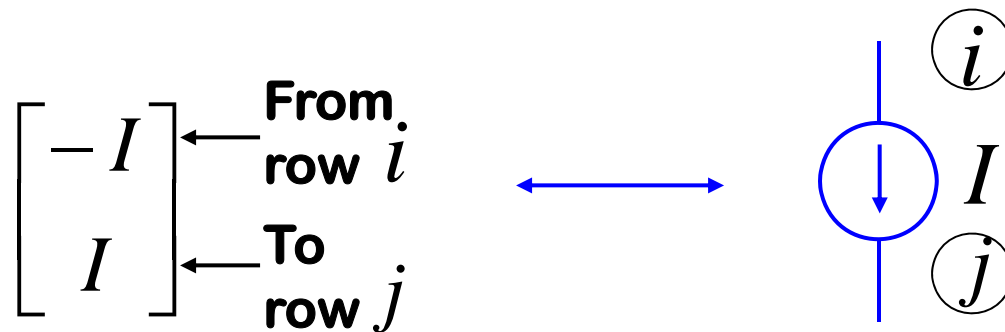
- ▶ Element stamps

Instead of converting the netlist into a graph and writing KCL eqns, *stamp* in elements one at a time:

Stamps: add to existing matrix entries



- RHS \vec{J} of equations are stamped in a similar way:

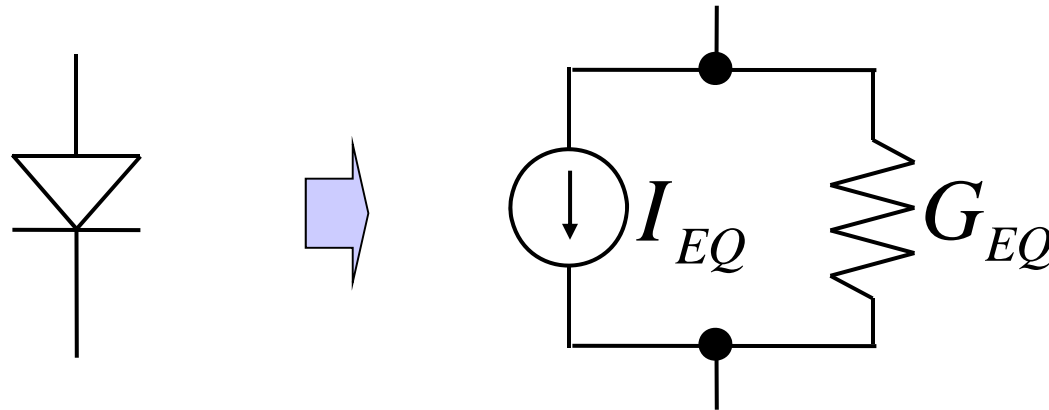


- Stamping our simple example one element at a time:

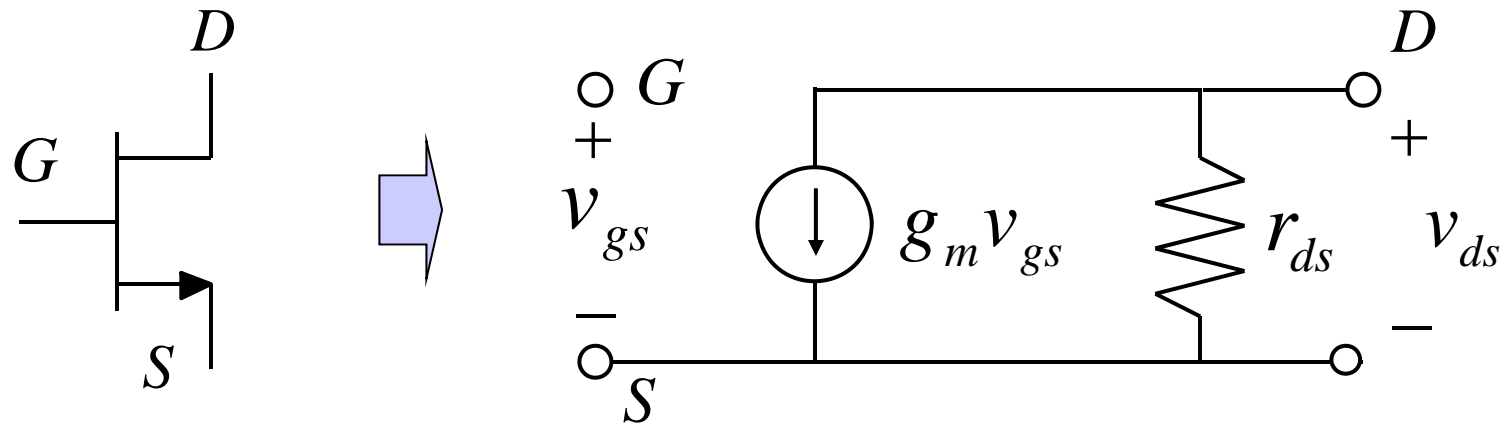
I_1	0	1	1 mA
R_1	1	0	$10\ \Omega$
R_2	1	2	$5\ \Omega$
R_3	2	0	$100\ \Omega$

$$\begin{bmatrix} G_1 + G_2 & -G_2 \\ -G_2 & G_2 + G_3 \end{bmatrix} \cdot \begin{bmatrix} V_1 \\ V_2 \end{bmatrix} = \begin{bmatrix} I_1 \\ 0 \end{bmatrix}$$

- We know that nonlinear elements are first converted to linear components, then stamped

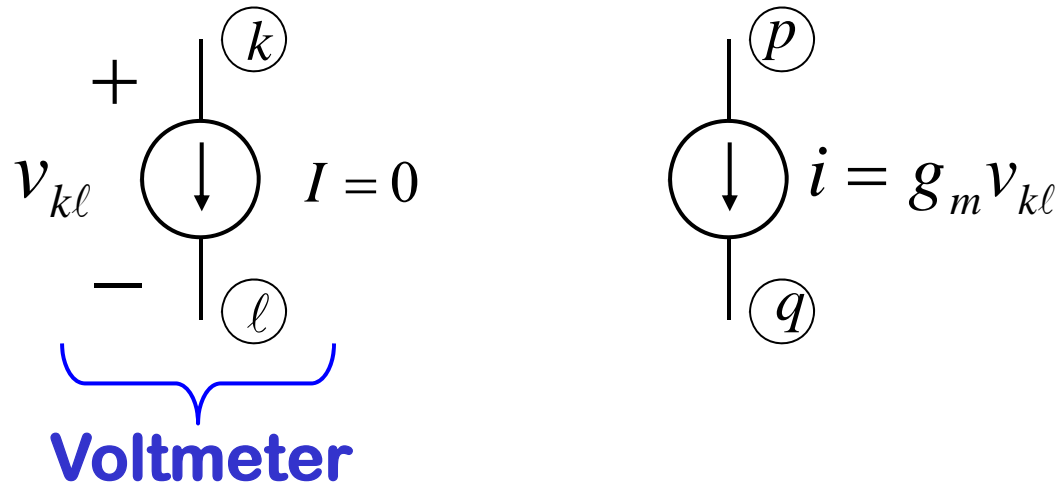


- For 3 & 4 terminal elements we know that the linearized models have linear controlled sources



- We can stamp in MOSFETs in terms of a complete stamp, or in terms of simpler element stamps

Voltage controlled current source

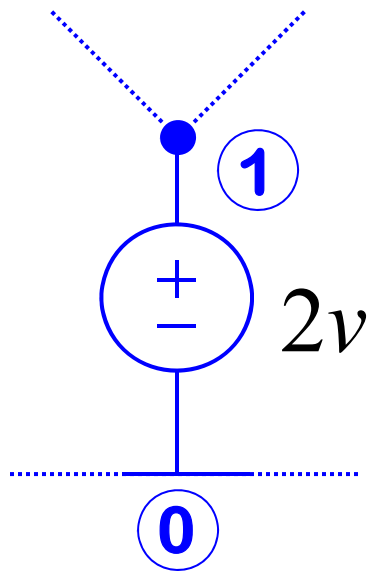


$$\begin{bmatrix} g_m & -g_m \\ -g_m & g_m \end{bmatrix} \begin{matrix} \leftarrow \text{row } p \\ \leftarrow \text{row } q \end{matrix}$$

$\uparrow \qquad \qquad \uparrow$
col k col l

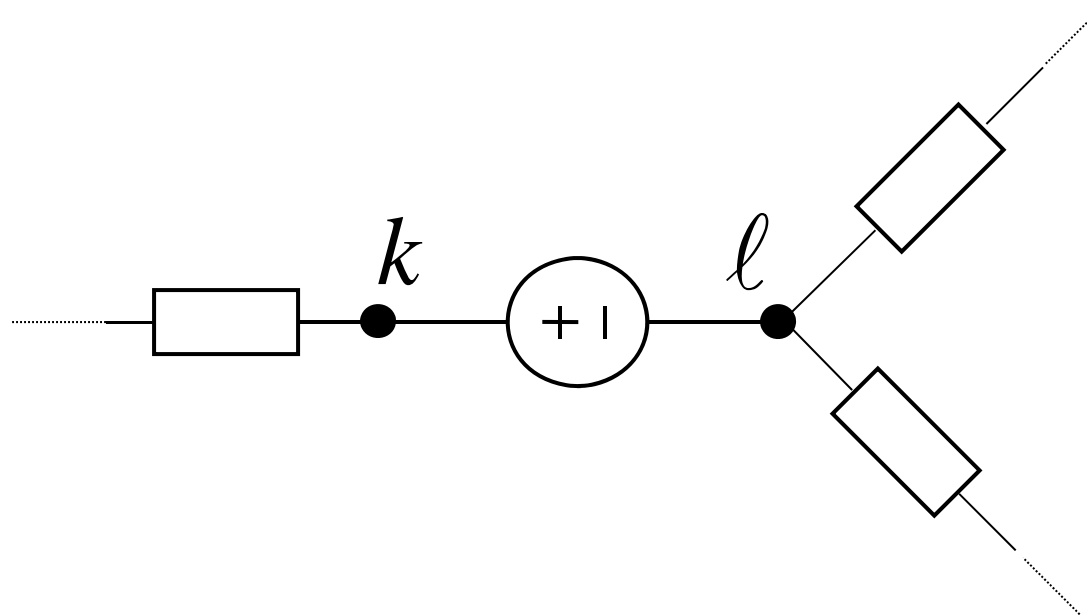
Large value that does not fall on diagonal of Y!

- ▶ All other types of controlled sources include voltage sources
- ▶ Voltage sources are inherently incompatible with nodal analysis
- ▶ Grounded voltages sources are easily accommodated



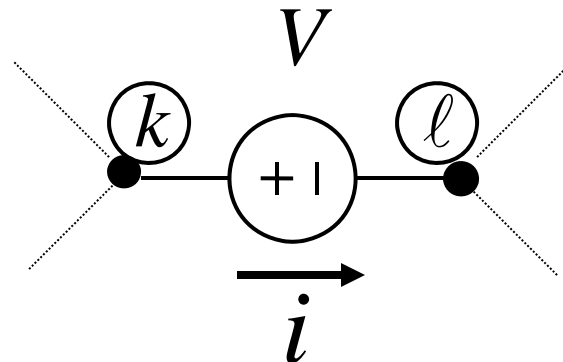
$$\begin{bmatrix} 1 & \dots \\ \vdots \end{bmatrix} \begin{bmatrix} v_1 \\ v_2 \\ \vdots \end{bmatrix} = \begin{bmatrix} 2 \\ \vdots \end{bmatrix}$$

- But a voltage source in between nodes is more difficult



- Node voltages k and l are not independent

- ▶ We no longer have N independent node voltage variables
- ▶ So we can potentially eliminate one equation and one variable (section 2.3 of reference [1])
- ▶ But the more popular solution is modified nodal analysis (MNA)



Create one extra variable and one extra equation

- ▶ Extra variable: voltage source current
- ▶ Allows us to write KCL at nodes k and ℓ
- ▶ Extra equation

$$v_k - v_\ell = V$$

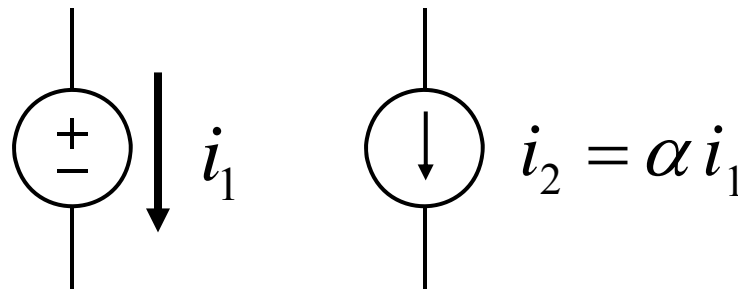
- ▶ Advantage: now have an easy way of printing current results - - ammeter

Voltage source stamp:

$$\begin{array}{rcl}
 \text{row } k & \left[\begin{array}{cc|c} & & 1 \\ & & -1 \\ 1 & -1 & 0 \end{array} \right] & \begin{bmatrix} \\ \\ i \end{bmatrix} = \begin{bmatrix} \\ \\ V \end{bmatrix} \\
 \text{row } \ell & & \\
 \text{row } N+1 & &
 \end{array}$$

$$\begin{array}{ccc}
 \text{col } k & \text{col } \ell & \text{col } N+1
 \end{array}$$

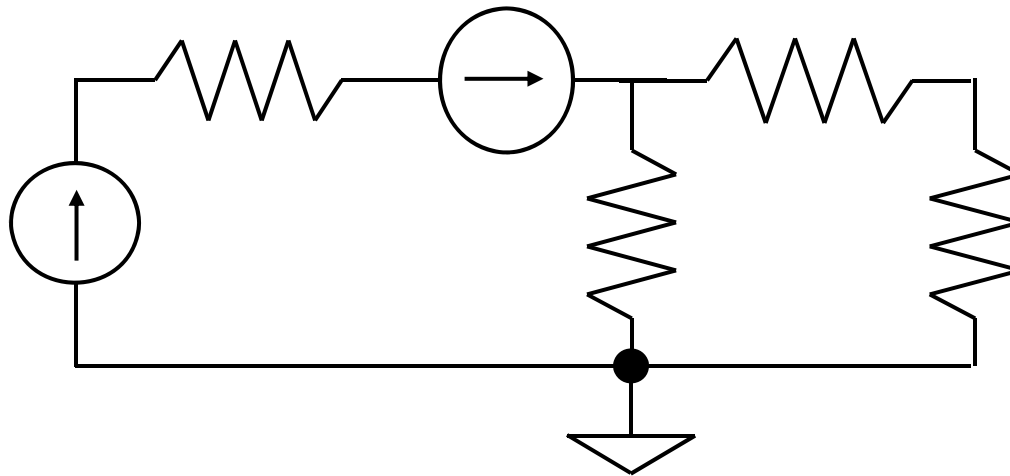
- **Current-controlled current source (e.g. BJT) has to stamp in an ammeter and a controlled current source**



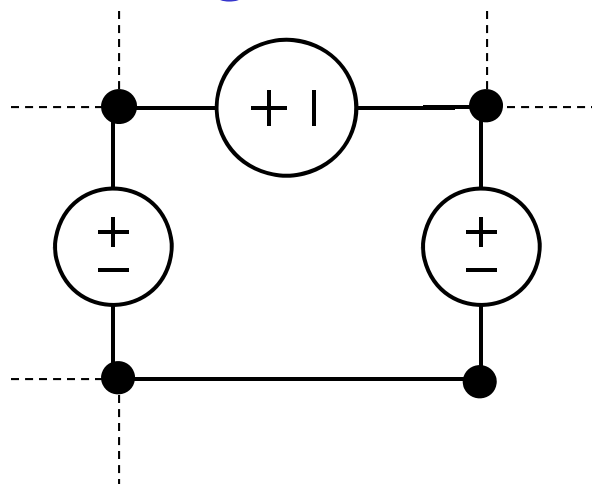
In general, we would not blindly build the matrix from an input netlist and then attempt to solve it

Various illegal ckts are possible:

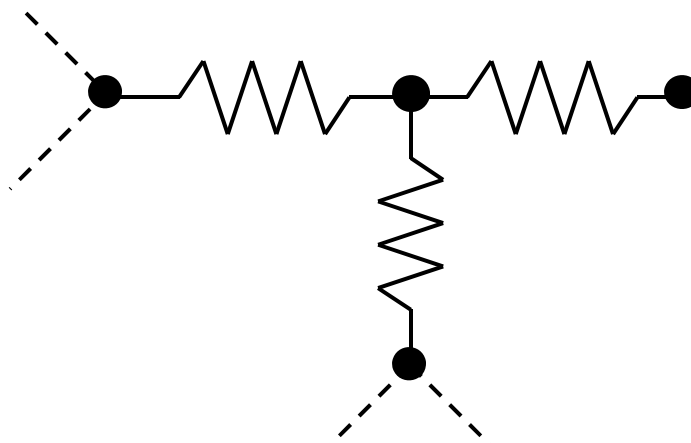
Cutsets of current sources



Loops of voltage sources

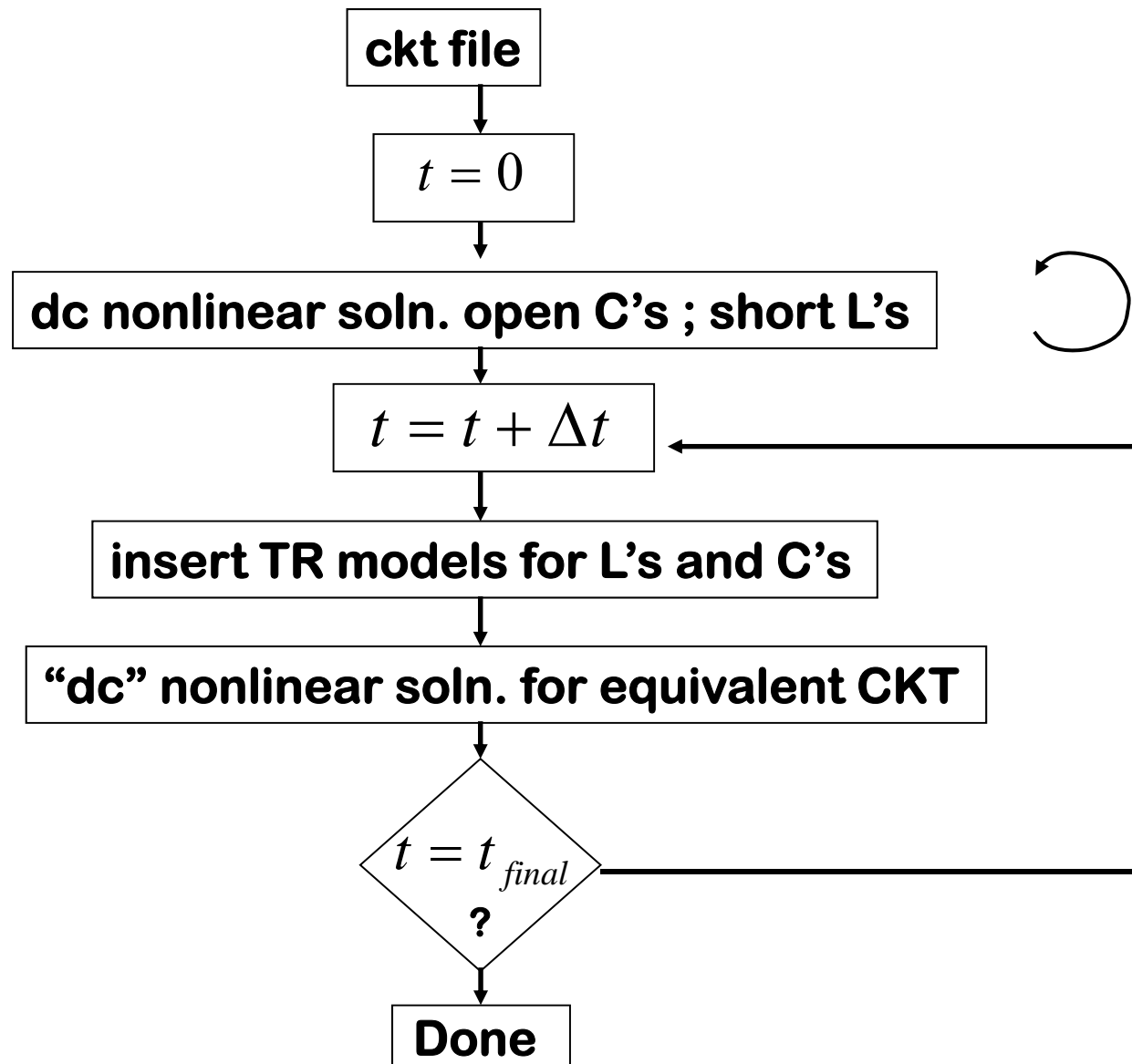


Dangling nodes



- Once we efficiently formulate MNA equations, an efficient solution to $Y\vec{v} = \vec{J}$ is even more important
- For large ckts the matrix is really sparse
 - ▶ Number of entries in Y is a function of number of elements connected to the corresponding node
- Inverting a **sparse matrix** is never a good idea since the inverse is **not sparse**!
- Instead direct solution methods employ Gaussian Elimination or LU factorization

■ TR analysis flow (Chap. 4 of ref. 2)



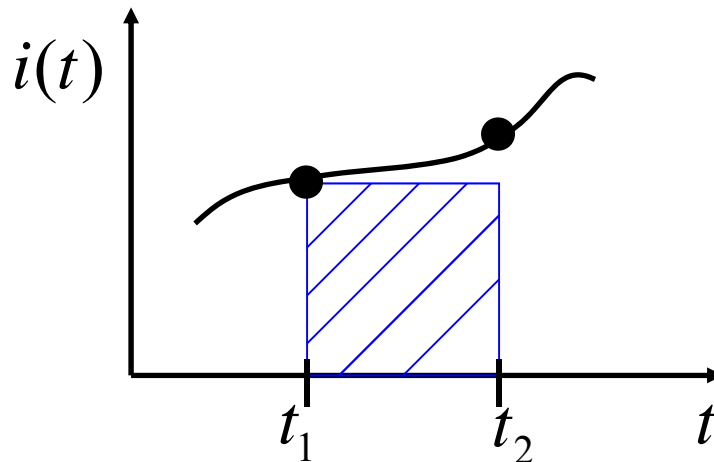
■ One-step integration approximation

$$\begin{array}{c} + \\ v \\ - \end{array} \quad \begin{array}{c} | \\ \hline \hline | \end{array} \quad \mathbf{C} \quad \begin{array}{c} \downarrow \\ \mathbf{i} \end{array} \quad i = C \frac{dv}{dt}$$

$$v(t + \Delta t) = v(t) + \frac{1}{C} \int_t^{t+\Delta t} i(\tau) d\tau$$

$$\int_i^{t+\Delta t} i(\tau) d\tau \approx \begin{cases} \Delta t \cdot i(t) & \text{Forward Euler (FE)} \\ \Delta t \cdot i(t + \Delta t) & \text{Backward Euler (BE)} \\ \frac{\Delta t}{2} [i(t) + i(t + \Delta t)] & \text{Trapezoidal (TR)} \end{cases}$$

- FE is explicit, and no nonlinear iterations are required
 - ▶ Extremely difficult to use in practice



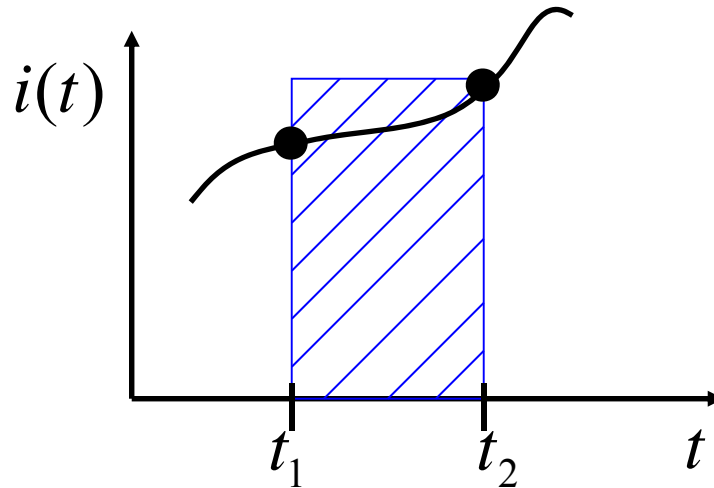
Forward Euler

$$\int_{t_1}^{t_2} i(t) dt \cong \Delta t \cdot i(t_1)$$

$$\Delta t = t_2 - t_1$$

■ BE is implicit

- ▶ Much more robust than FE
- ▶ Can also make unstable responses appear stable

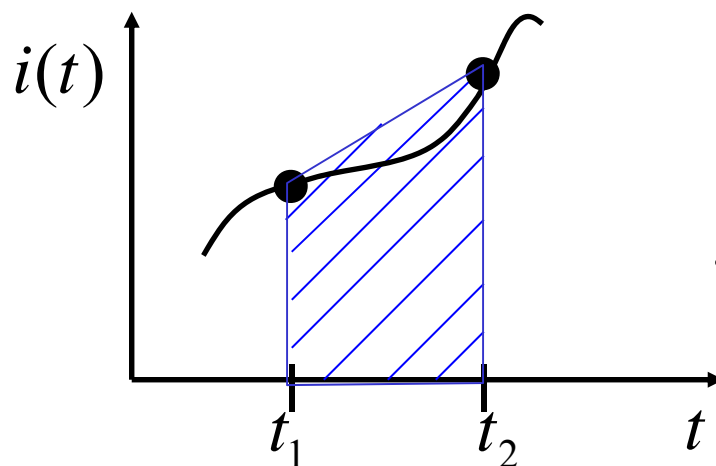


Backward Euler

$$\int_{t_1}^{t_2} i(t) dt \cong \Delta t \cdot i(t_2)$$

■ TR is implicit too

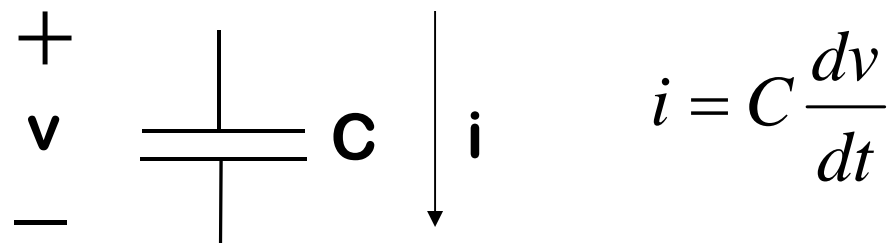
- ▶ Works similarly to BE
- ▶ Incurs less error



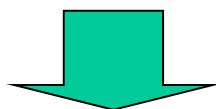
Trapezoidal

$$\int_{t_1}^{t_2} i(t) dt \cong \frac{\Delta t}{2} \cdot (i(t_1) + i(t_2))$$

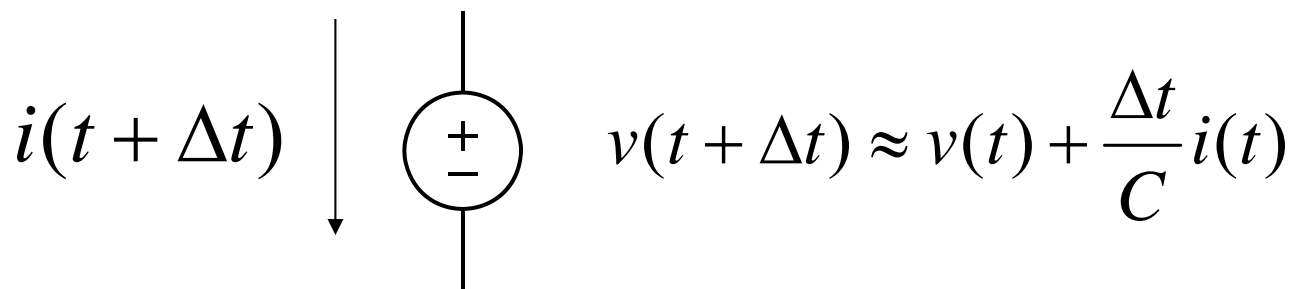
■ FE Capacitor Companion Model



$$i = C \frac{dv}{dt}$$

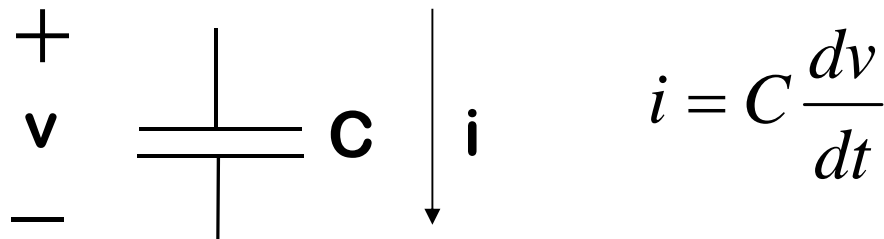


$$\int_t^{t+\Delta t} i(\tau) d\tau \approx \Delta t \cdot i(t)$$

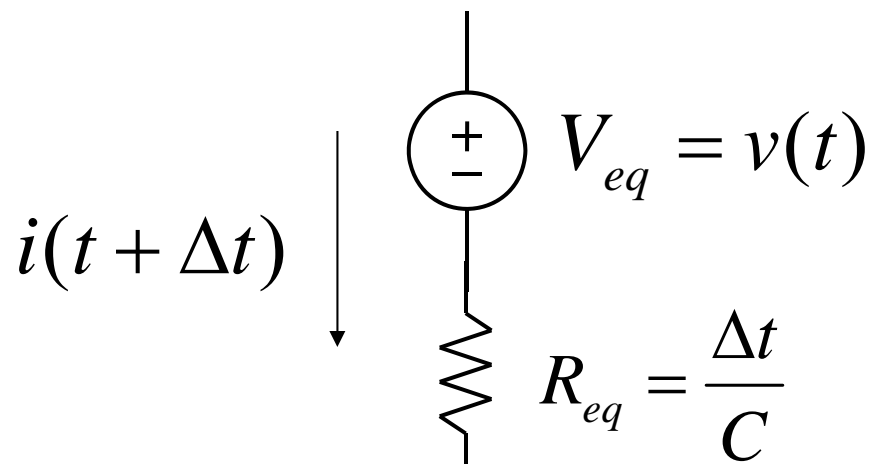


■ BE Capacitor Companion Model

► Thevenin

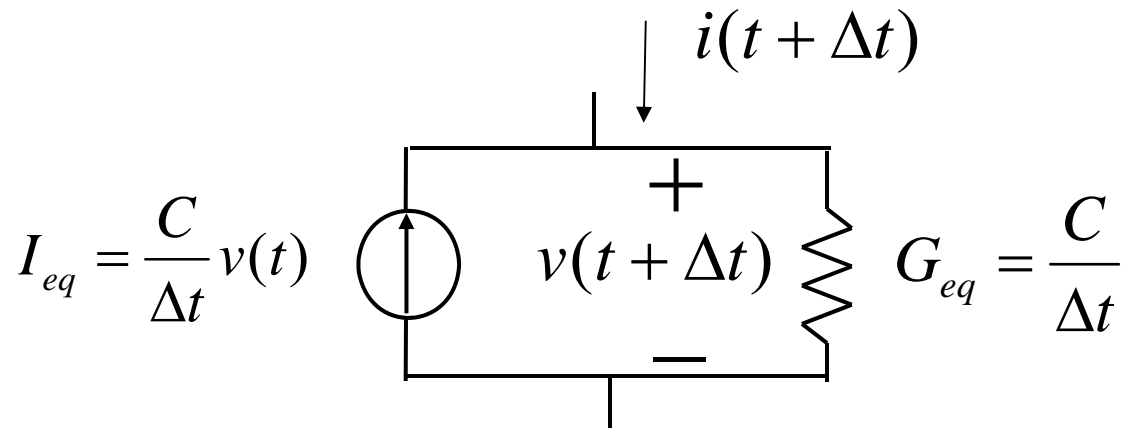


$$\int_t^{t+\Delta t} i(\tau) d\tau \approx \Delta t \cdot i(t + \Delta t)$$



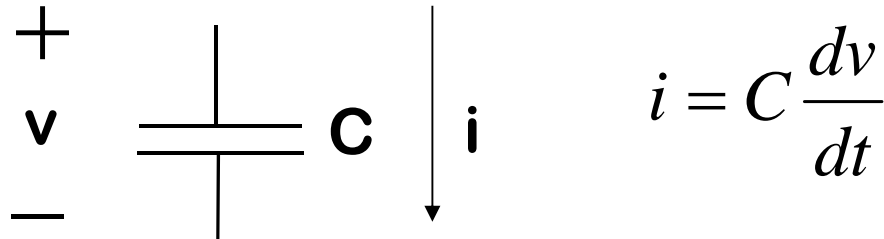
■ BE Capacitor Companion Model

► Norton




■ TR Capacitor Companion Model

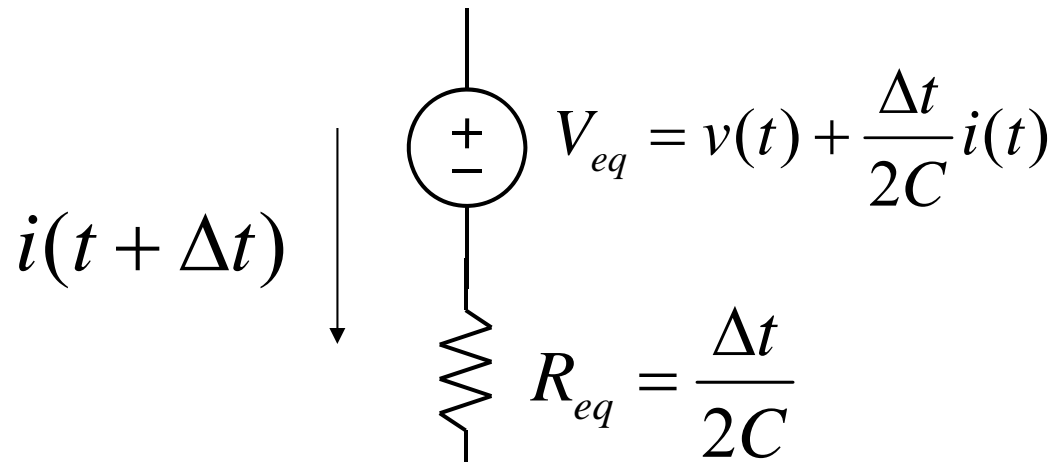
► Thevenin



$$i = C \frac{dv}{dt}$$

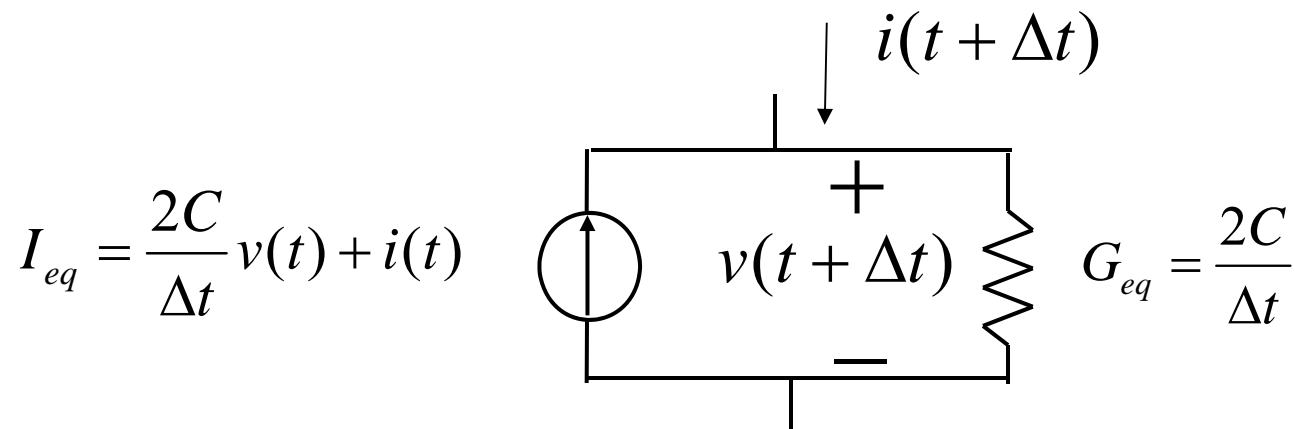


$$\int_t^{t+\Delta t} i(\tau) d\tau \approx \frac{\Delta t}{2} \cdot (i(t) + i(t + \Delta t))$$



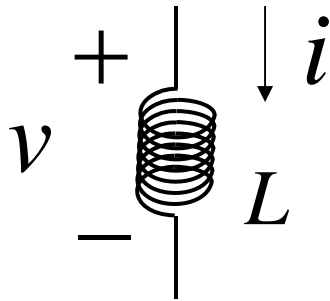
■ TR Capacitor Companion Model

► Norton




■ TR Inductor Companion Model

► Norton

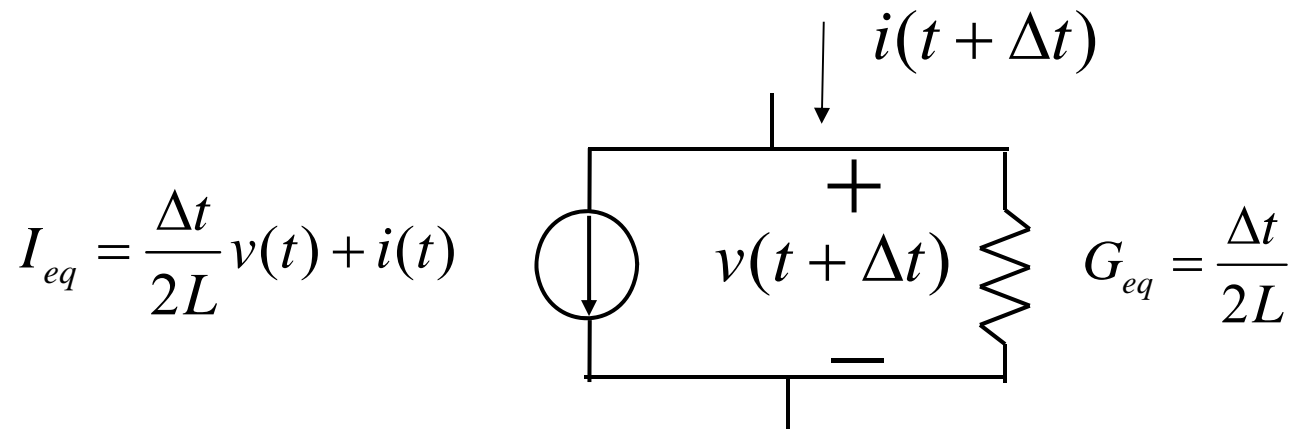


$$v = \frac{L di}{dt}$$

$$i(t + \Delta t) = i(t) + \frac{1}{L} \int v(\tau) d\tau$$

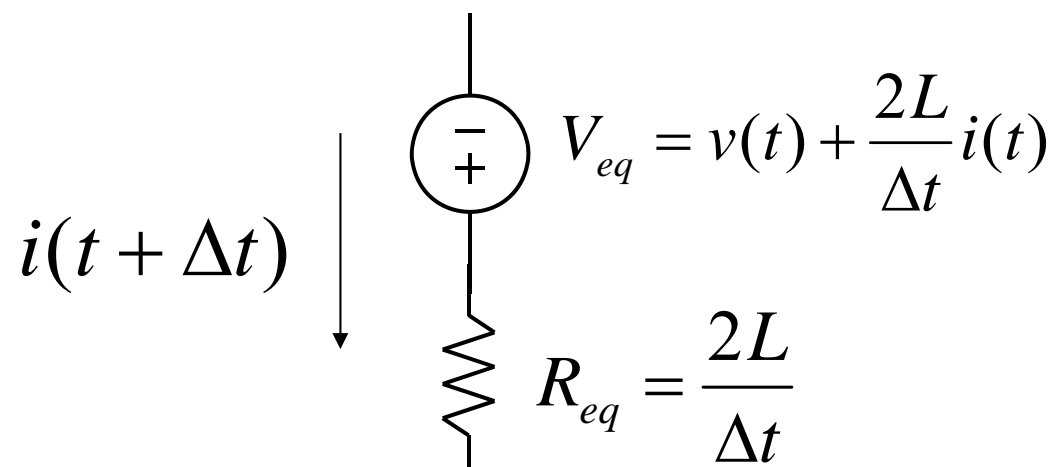


$$\int_t^{t+\Delta t} v(\tau) d\tau \approx \frac{\Delta t}{2} \cdot (v(t) + v(t + \Delta t))$$



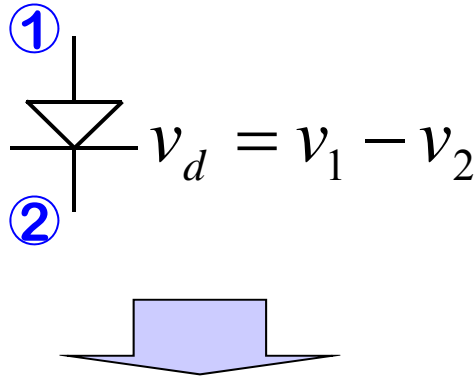
■ TR Inductor Companion Model

► Thevenin



- **Nonlinear DC analysis (Chapter 10.6 – 10.8 of Ref. 2)**
 - ▶ Store device equations and their partial derivatives w.r.t. branch voltages for efficient N-R procedure:
 - ▼ Insert linearized models into MNA formulation (first order Taylor series at operating point)
 - ▼ Solve the linear ckt to complete one N-R iteration
 - ▼ Use the solution as operating pt. for next linearization step

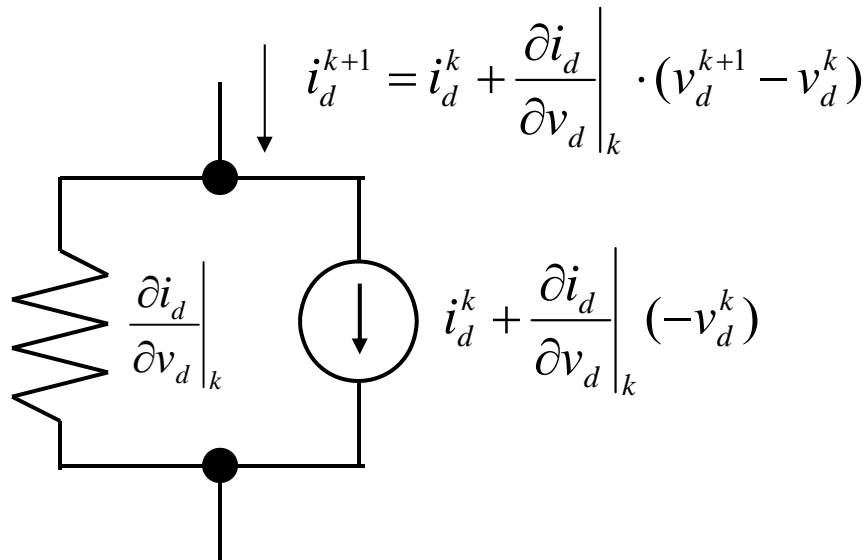
► Diode equations and companion model for N-R



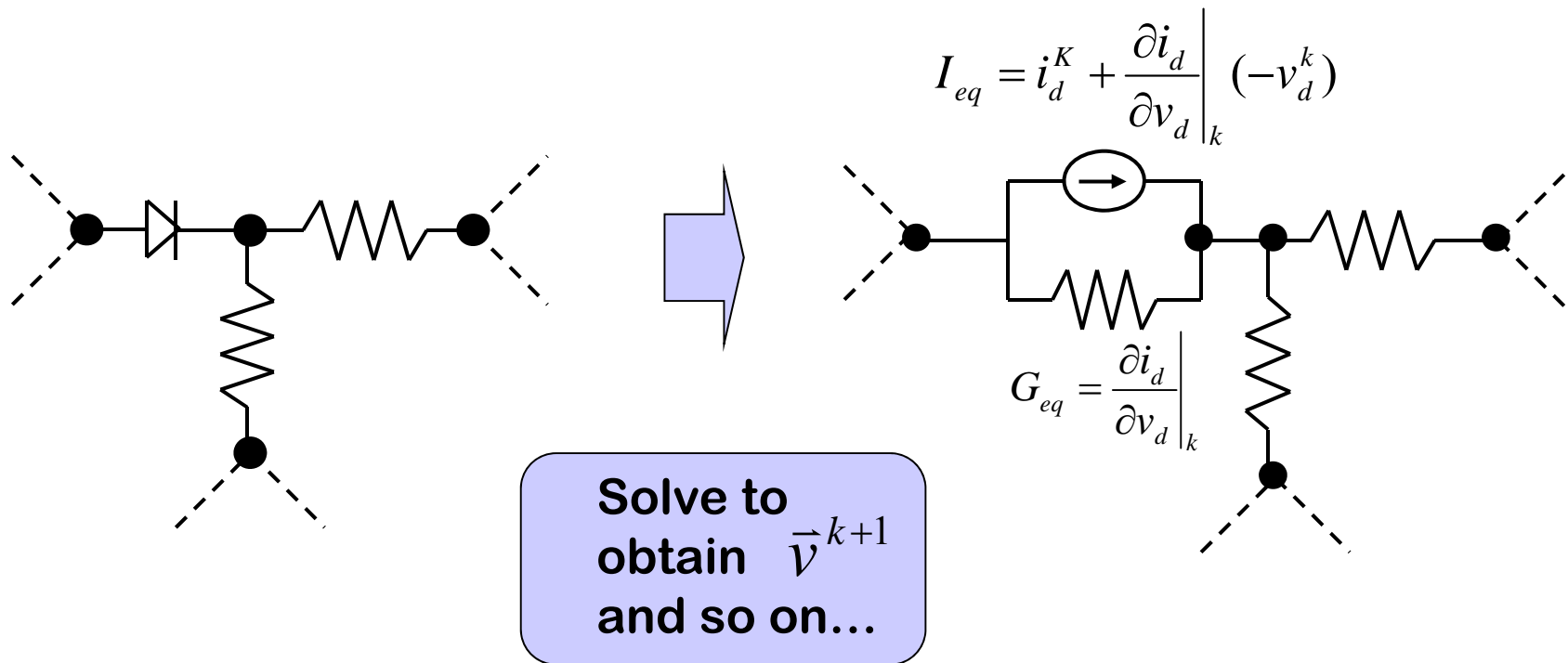
$$i_d = I_s (e^{v_d/V_T} - 1)$$

$$\frac{\partial i_d}{\partial v_d} = \frac{I_s}{V_T} e^{v_d/V_T}$$

**Stored
Model
Eqns.**



- Diodes are modeled by Norton equivalent companion models



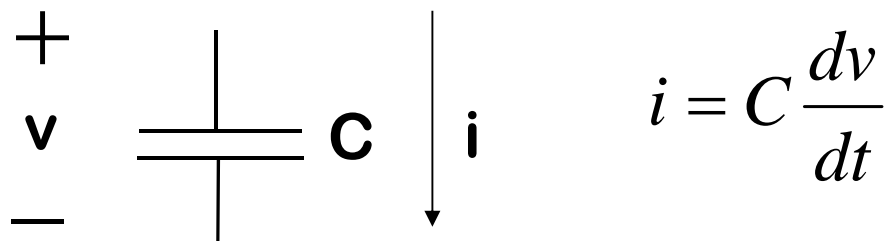
- Some sort of voltage limiting scheme is required to make N-R iterations robust

■ Recap: linear transient analysis

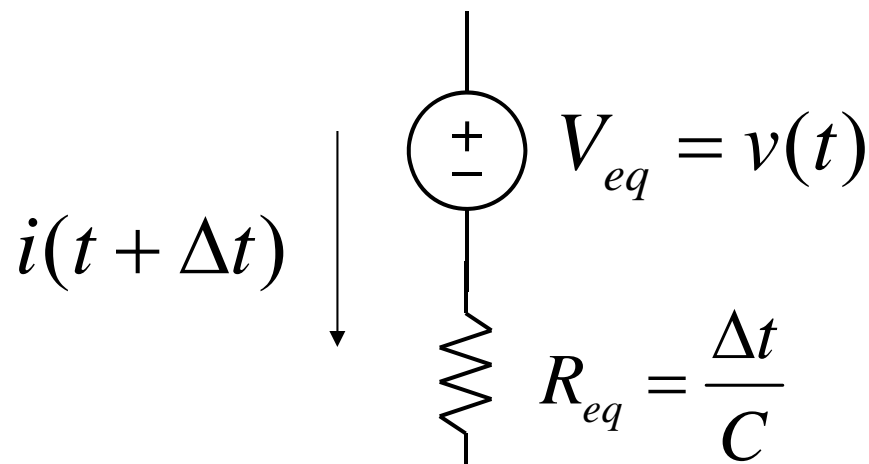
- ▶ Replace each of C's and L's by a companion model – numerical integration
 - ▼ Forward Euler, Backward Euler, Trapezoidal
 - ▼ Norton or Thevenin models
- ▶ Solve the equivalent linear circuit at the current time step
- ▶ Update all the companion models and move to the next time step

■ Example: BE capacitor companion models

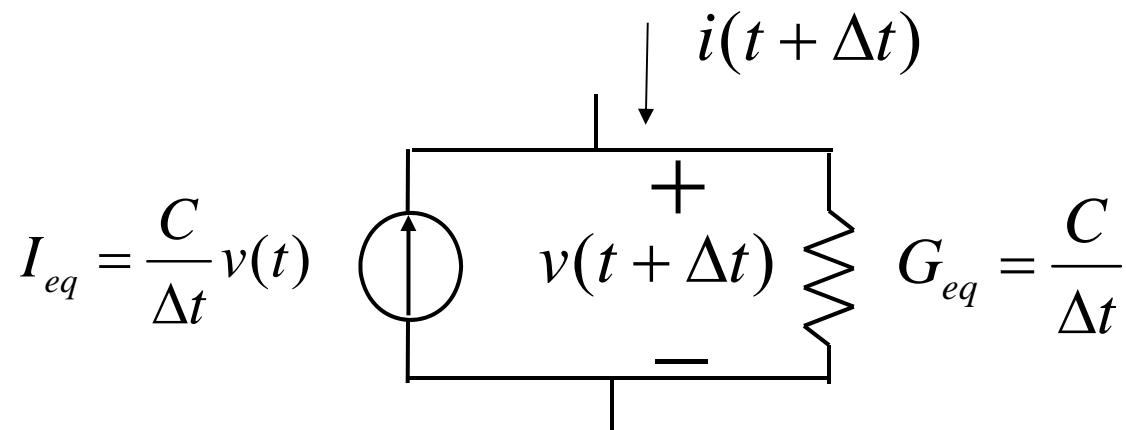
► Thevenin



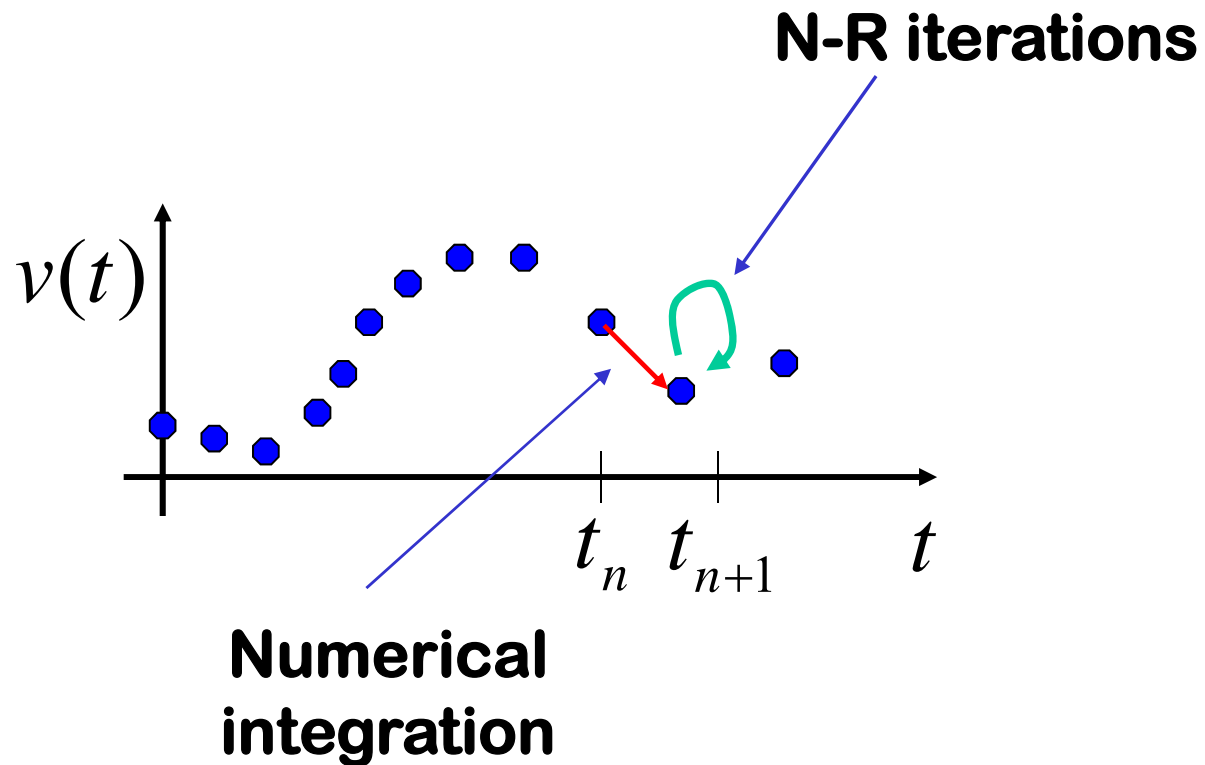
$$\int_t^{t+\Delta t} i(\tau) d\tau \approx \Delta t \cdot i(t + \Delta t)$$



► Norton

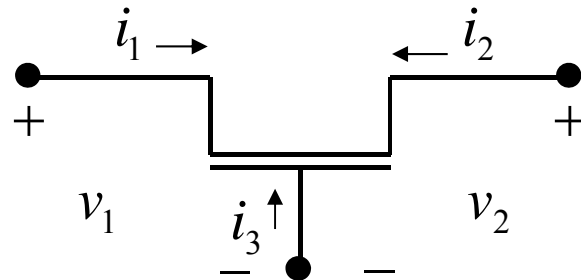


- We combine the above two in nonlinear transient analysis



- Start from some initial condition at time t_0
- Move to the next time step by replacing all the C's & L's by a companion model
 - ▶ Solve the equivalent nonlinear DC problem at the new time point
 - ▼ Use the solution at the previous time step as the initial guess for N-R
 - ▼ Iterate till convergence
- Repeat till reaching the ending time
- Nonlinear dynamic elements need to be handled more carefully
 - ▶ Charge conservation – more on this later

- What about nonlinear elements with more than 2 terminals?



- Nonlinear equations:

$$i_1 = g_1(v_1, v_2) \quad i_2 = g_2(v_1, v_2)$$

$$i_3 = -i_1 - i_2 \quad \text{Port Equations}$$

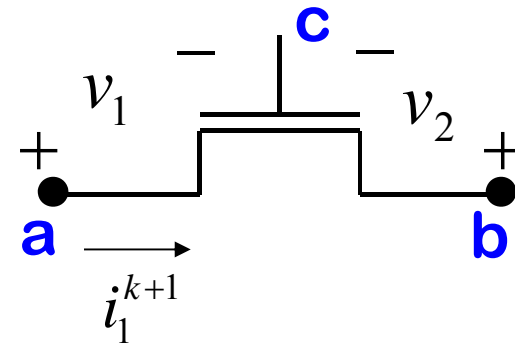
- Once again, model by first 2 terms of Taylor series

$$i_1^{k+1} = i_1^k + \Delta i_1^k = g_1(v_1^k, v_2^k) + \left. \frac{\partial g_1}{\partial v_1} \right|_k \cdot \Delta v_1 + \left. \frac{\partial g_1}{\partial v_2} \right|_k \cdot \Delta v_2$$

$$i_2^{k+1} = i_2^k + \Delta i_2^k = g_2(v_1^k, v_2^k) + \left. \frac{\partial g_2}{\partial v_1} \right|_k \cdot \Delta v_1 + \left. \frac{\partial g_2}{\partial v_2} \right|_k \cdot \Delta v_2$$

$$\begin{aligned} i_3^{k+1} = i_3^k + \Delta i_3^k = & -g_1(v_1^k, v_2^k) - g_2(v_1^k, v_2^k) \\ & + \left(\frac{-\partial g_1}{\partial v_1} - \frac{\partial g_2}{\partial v_1} \right) \bigg|_k \Delta v_1 + \left(\frac{-\partial g_1}{\partial v_2} - \frac{\partial g_2}{\partial v_2} \right) \bigg|_K \Delta v_2 \end{aligned}$$

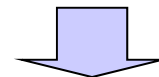
3-Terminal MOSFET Stamp:



► Consider the current contribution at each node

► Note that we must translate port voltages to node voltages

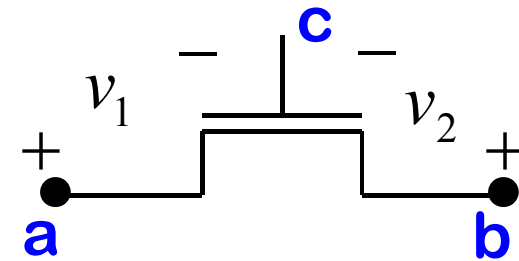
$$\begin{aligned} v_1 &= v_a - v_c \\ v_2 &= v_b - v_c \end{aligned} \quad \Rightarrow \quad i_1^{k+1} = i_1^k + \Delta i_1^k = g_1(v_1^k, v_2^k) + \left. \frac{\partial g_1}{\partial v_1} \right|_k \cdot \Delta v_1 + \left. \frac{\partial g_1}{\partial v_2} \right|_k \cdot \Delta v_2$$



$$i_1^{k+1} = i_1^k + \Delta i_1^k = g_1(v_1^k, v_2^k) + \left. \frac{\partial g_1}{\partial v_1} \right|_k \cdot \Delta v_a + \left. \frac{\partial g_1}{\partial v_2} \right|_k \cdot \Delta v_b - \left(\left. \frac{\partial g_1}{\partial v_1} \right|_k + \left. \frac{\partial g_1}{\partial v_2} \right|_k \right) \cdot \Delta v_c$$

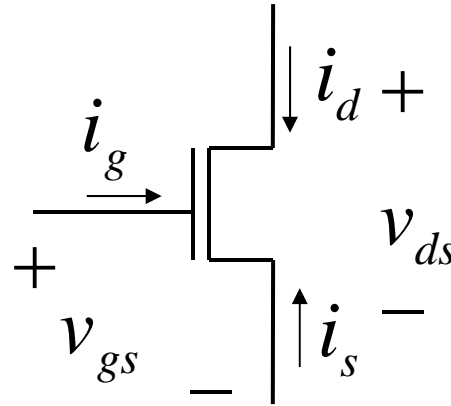
3-Terminal MOSFET Stamp:

- Most solvers are set up to solve for $\Delta \vec{v}$ instead of \vec{v}^{k+1}



$$\begin{array}{c}
 \begin{array}{c} \mathbf{a} \\ \mathbf{b} \\ \mathbf{c} \end{array}
 \begin{bmatrix}
 \frac{\partial g_1^k}{\partial v_1} & \dots & \frac{\partial g_1^k}{\partial v_2} & \dots & \left(\frac{-\partial g_1^k}{\partial v_1} - \frac{\partial g_1^k}{\partial v_2} \right) \\
 \vdots & & \vdots & & \vdots \\
 \frac{\partial g_2^k}{\partial v_1} & \dots & \frac{\partial g_2^k}{\partial v_2} & \dots & \left(\frac{-\partial g_2^k}{\partial v_1} - \frac{\partial g_2^k}{\partial v_2} \right) \\
 \vdots & & \vdots & & \vdots \\
 \left(\frac{-\partial g_1^k}{\partial v_1} - \frac{\partial g_2^k}{\partial v_1} \right) & \dots & \left(\frac{-\partial g_1^k}{\partial v_2} - \frac{\partial g_2^k}{\partial v_2} \right) & \dots & \left\{ \frac{\partial g_1^k}{\partial v_1} + \frac{\partial g_1^k}{\partial v_2} + \frac{\partial g_2^k}{\partial v_1} - \frac{\partial g_2^k}{\partial v_2} \right\}
 \end{bmatrix}
 \begin{array}{c}
 \Delta \vec{v} \\
 \Downarrow \\
 \begin{bmatrix} \vdots \\ \Delta v_a \\ \vdots \\ \Delta v_b \\ \vdots \\ \Delta v_c \end{bmatrix}
 \end{array}
 =
 \begin{bmatrix} \vdots \\ -g_1(v_1^k, v_2^k) \\ \vdots \\ -g_2(v_1^k, v_2^k) \\ \vdots \\ g_1(v_1^k, v_2^k) \\ +g_2(v_1^k, v_2^k) \end{bmatrix}
 \end{array}$$

MOSFETs (3 terminal)



Triode Region

$$i_{ds} = \beta \left[(v_{gs} - v_{TH}) v_{ds} - \frac{v_{ds}^2}{2} \right] (1 + \lambda v_{ds})$$

$$v_{ds} < v_{gs} - v_{TH}$$

$$\beta = \mu C_{ox} \frac{W}{L}$$

$$v_{gs} - v_{TH} > 0$$

Saturation Region

$$i_{ds} = \frac{\beta}{2} [(v_{gs} - v_{TH})^2] \cdot (1 + \lambda v_{ds})$$

$$v_{ds} > v_{gs} - v_{TH}$$

Cutoff Region

$$i_{ds} = 0 \quad v_{gs} < v_{TH}$$

dc port equations:

$$i_g = 0$$

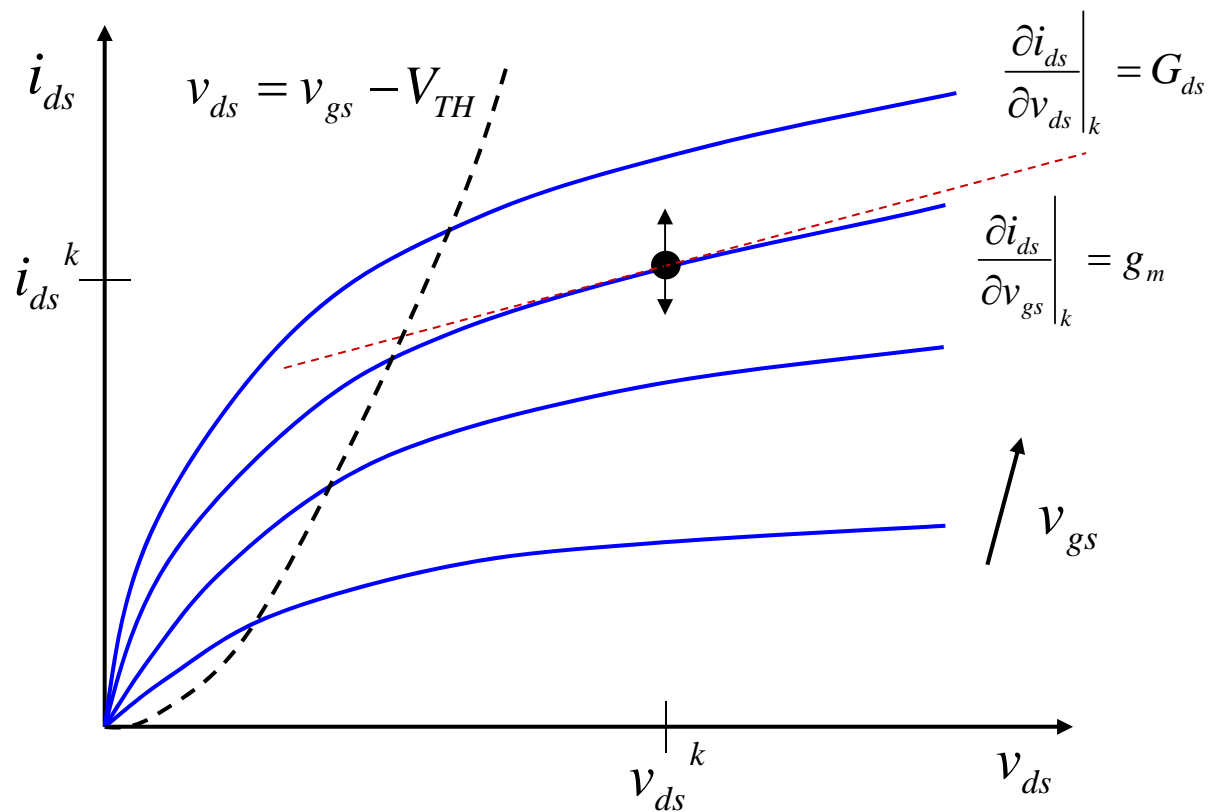
$$i_d = i_{ds}(v_{gs}, v_{ds})$$

$$i_s = -i_d = -i_{ds}(v_{gs}, v_{ds})$$

$$i_d^{k+1} = i_d^k + \Delta i_d^k = i_{ds}(v_{gs}^k, v_{ds}^k) +$$

$$\left. \frac{\partial i_{ds}}{\partial v_{gs}} \right|_k \cdot (v_{gs}^{k+1} - v_{gs}^k)$$

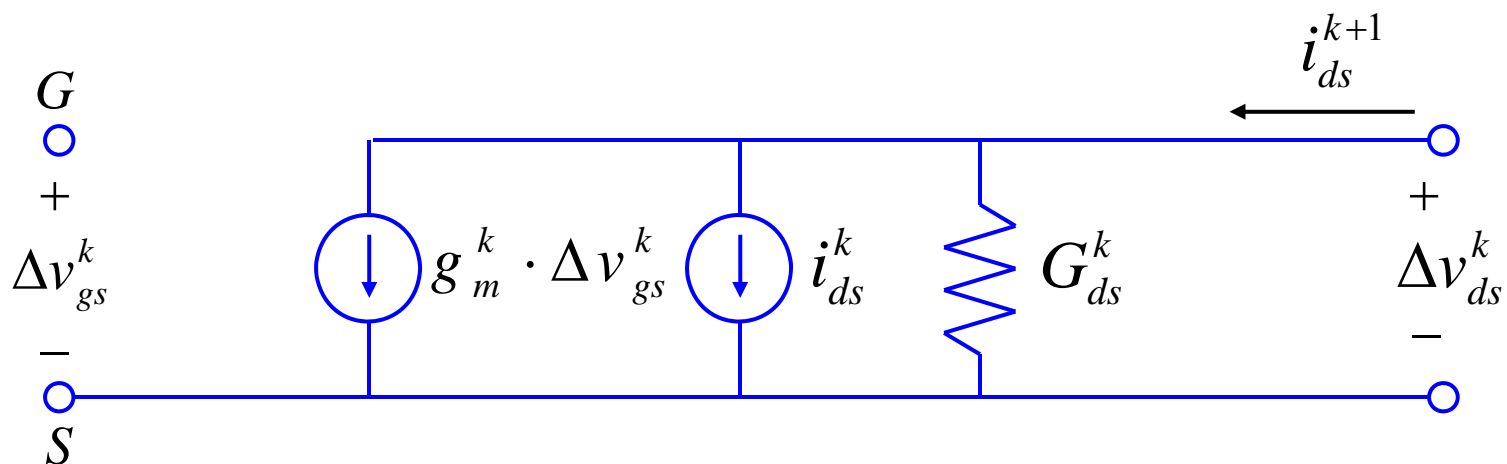
$$+ \left. \frac{\partial i_{ds}}{\partial v_{ds}} \right|_k \cdot (v_{ds}^{k+1} - v_{ds}^k)$$



$$i_{ds}^{k+1} = i_{ds}^k + g_m^k \cdot \Delta v_{gs}^k + G_{ds}^k \cdot \Delta v_{ds}^k$$

Equivalent ckt model for N-R

$$i_{ds}^{k+1} = i_{ds}^k + g_m \Delta v_{gs}^k + G_{ds}^k \cdot \Delta v_{ds}^k$$



$$\Delta v_{gs}^k = (v_{gs}^{k+1} - v_{gs}^k)$$

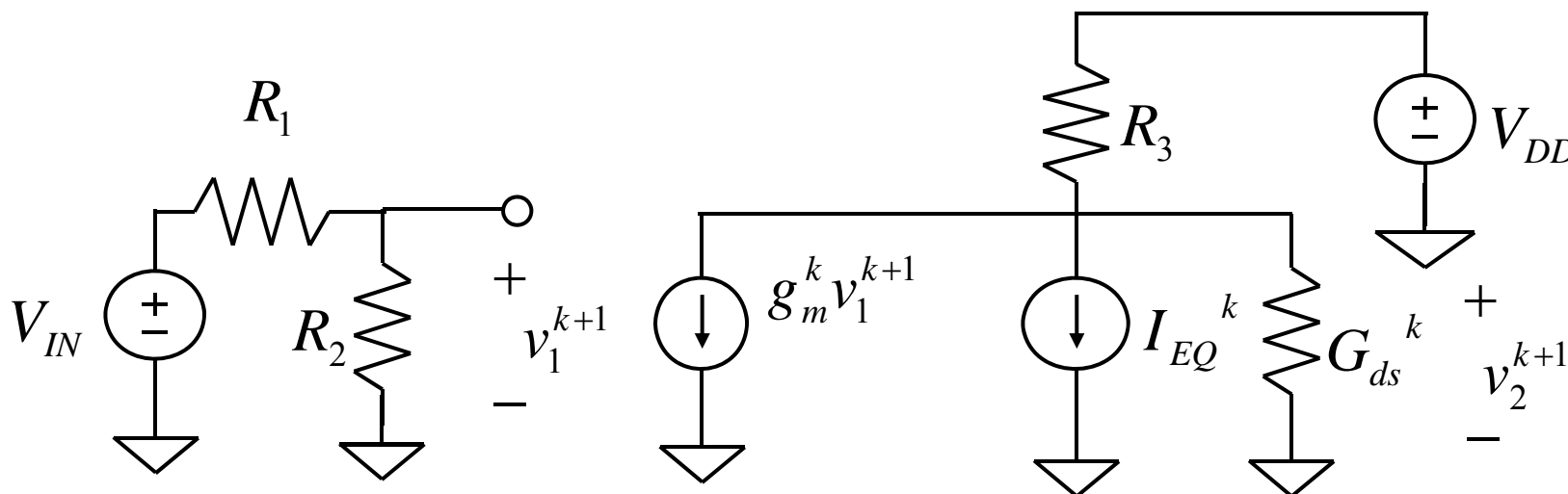
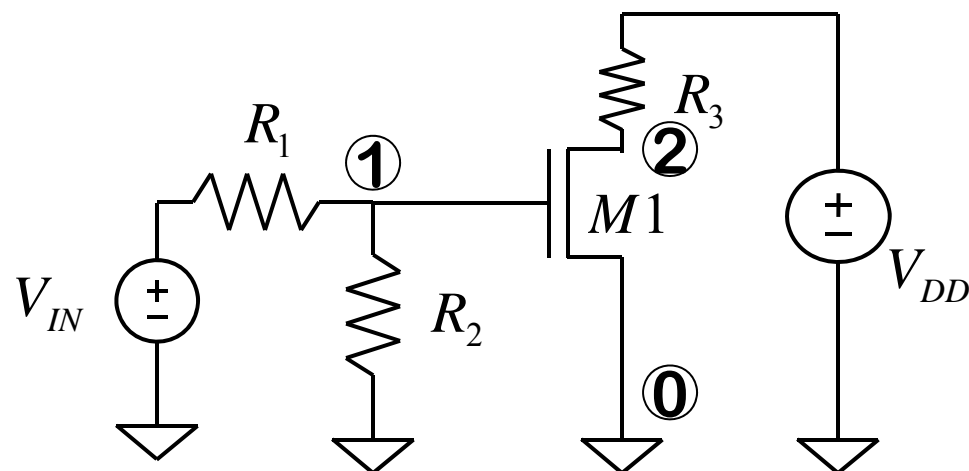
$$\Delta v_{ds}^k = (v_{ds}^{k+1} - v_{ds}^k)$$

- ▶ Could also build models to solve for v_{gs}^{k+1} and v_{ds}^{k+1} directly
- ▶ Stamping in terms for all of these 2-terminal elements is equivalent to applying MOSFET stamp
- ▶ Note the large off-diagonal terms that are created by g_m 's

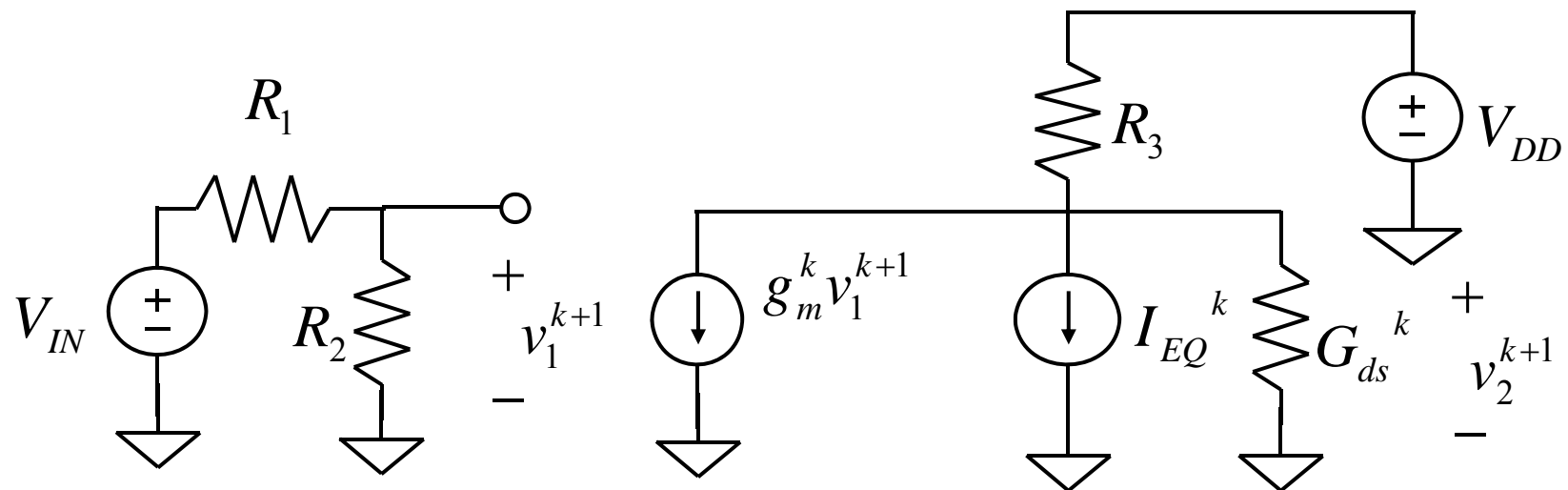
Simple Example

$$g_m^k = \left. \frac{\partial i_{ds}}{\partial v_{gs}} \right|_k \quad G_{ds}^k = \left. \frac{\partial i_{ds}}{\partial v_{ds}} \right|_k$$

$$I_{EQ}^k = i_{ds}^k + g_m^k (-v_{gs}^k) + G_{ds}^k (-v_{ds}^k)$$

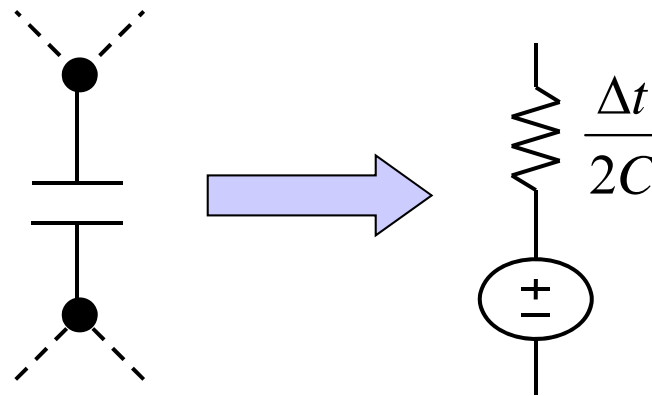


- Now formulate the nodal equations for this linearized equivalent ckt



- g_m , G_{ds} and I_{EQ} values change at each N-R iteration
- Damping methods control the N-R convergence
 - ▶ More of a problem for BJTS
- In general, we would include the 4-th terminal of the MOSFET (body effect)

- We use dc nonlinear algorithms find solution at $t=0$ AND for all timepoints
- Energy storage elements are properly considered by numerical integration



- How about nonlinear capacitors?

► Conventional NL device models

- $i_{ds} = f(v_{ds}, v_{gs}, v_{sb})$ -- 30+ parameters
- Accurate evaluation can be very expensive

► NR requires full evaluation of models

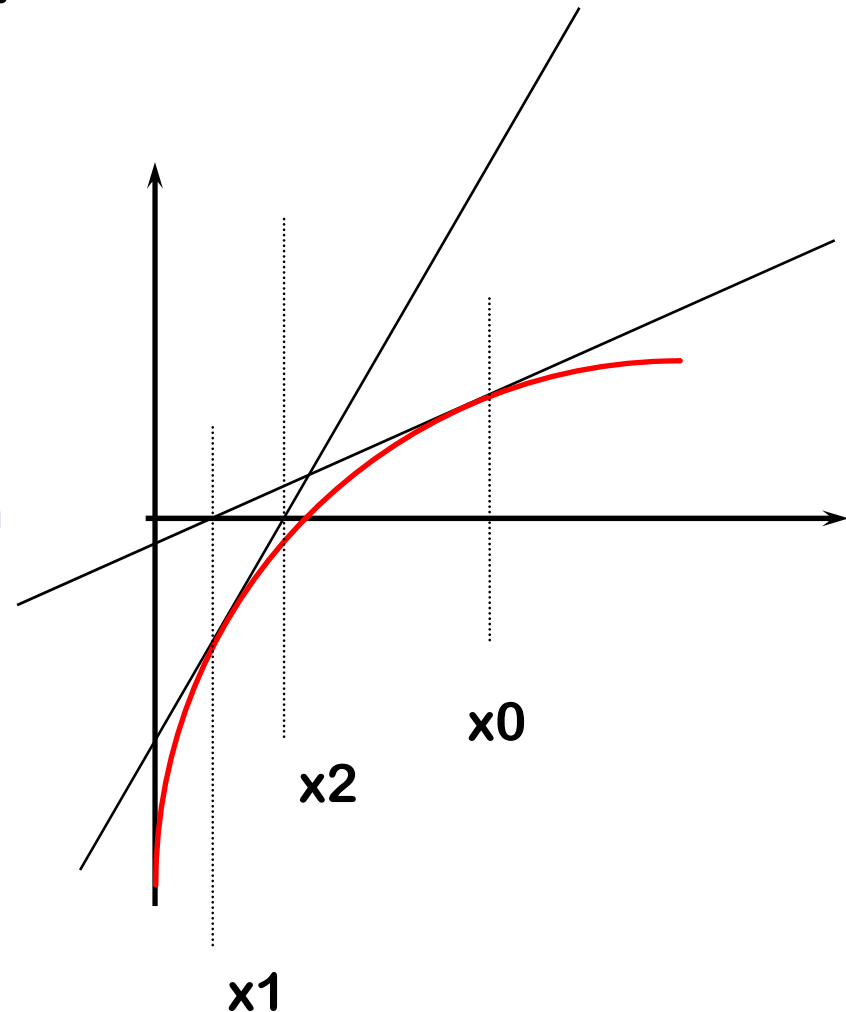
- Derivatives required for Jacobian
 - ▼ Expensive to evaluate -- can consume 50-80% of computation time

► SC-based approach

- No derivatives to re-organize – approximate Jacobian
- Will work with table models, measured data
- Reduced model evaluation time, but is based on:
 - ▼ Slower convergence (depending on the J_{approx})
 - ▼ Matrix update required for varying timesteps
 - ▼ Selection of representative linear model in J_{approx}

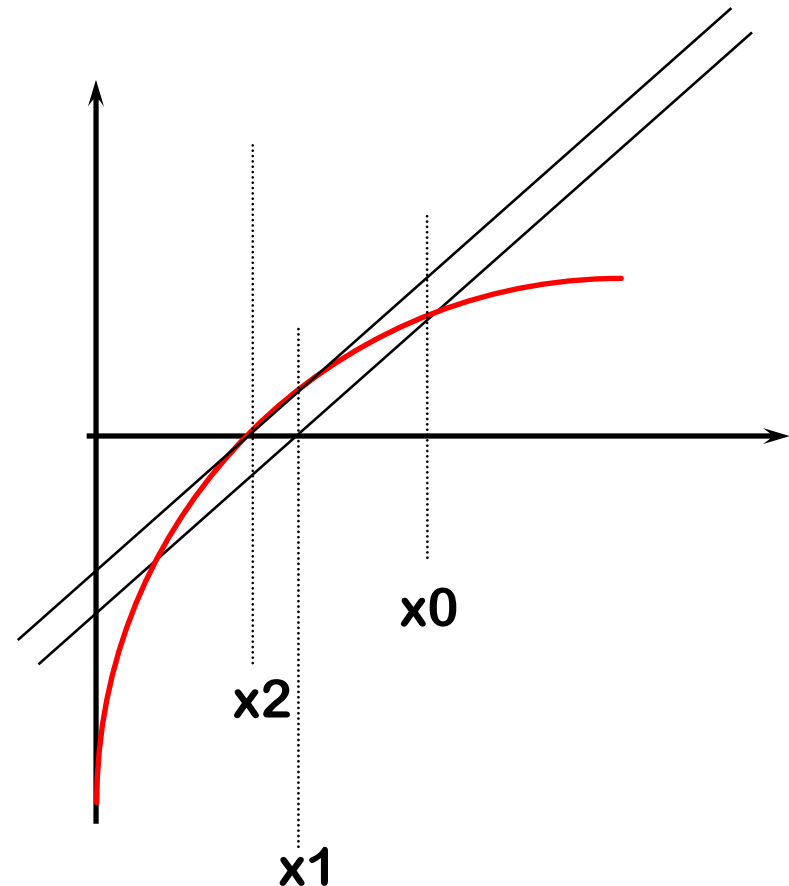
Newton-Raphson

- ▶ Good convergence properties
- ▶ Reliable when implemented with a step-limiting mechanism (damped)
- ▶ Requires explicit differentiation
- ▶ n-D case: Jacobian Matrix stamping (update) and re-factorization

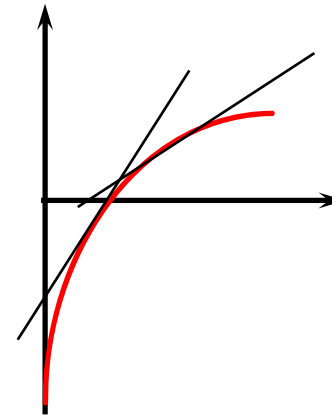


Successive Chord

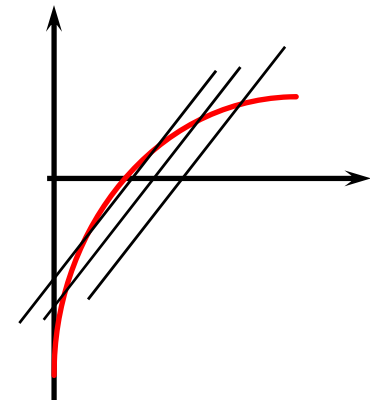
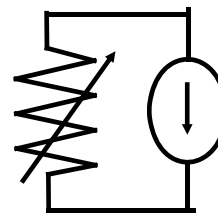
- ▶ $J(x)$ represents a fixed gradient (Jacobian)
- ▶ No explicit differentiation
- ▶ Reliable when implemented with a step-limiting mechanism (damped)
- ▶ n-D case: Single Jacobian factorization improvement by optional updates



- ▶ NR has varying R, I
- ▶ SC has fixed R
- ▶ Linearized network changes for each NR step, i.e. $J(x_n)$
- ▶ Single linearized network for SC steps, J_{approx}



Newton-Raphson



Successive Chord

